



Quanta Image Sensor (QIS) Concept and Progress

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October 1, 2014
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- Prof. Atsushi Hamasaki
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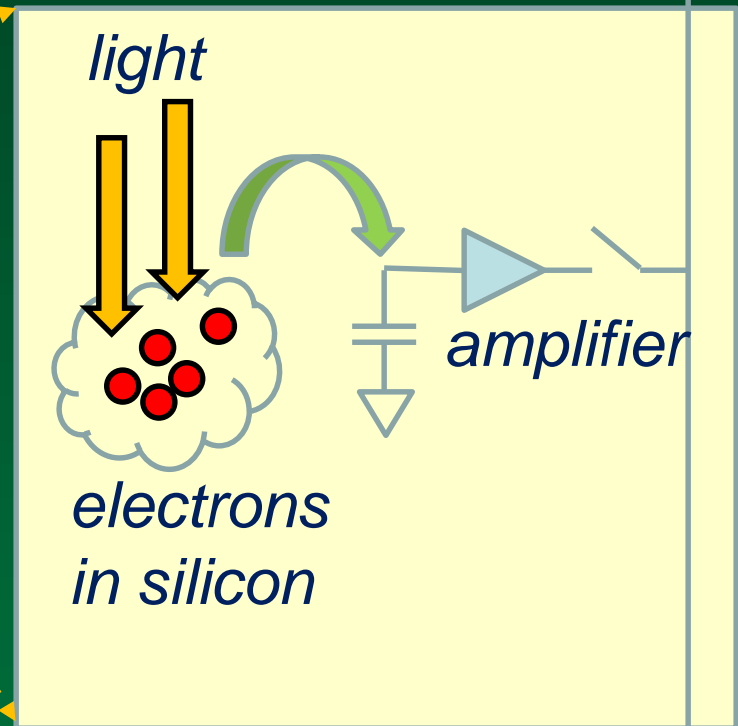
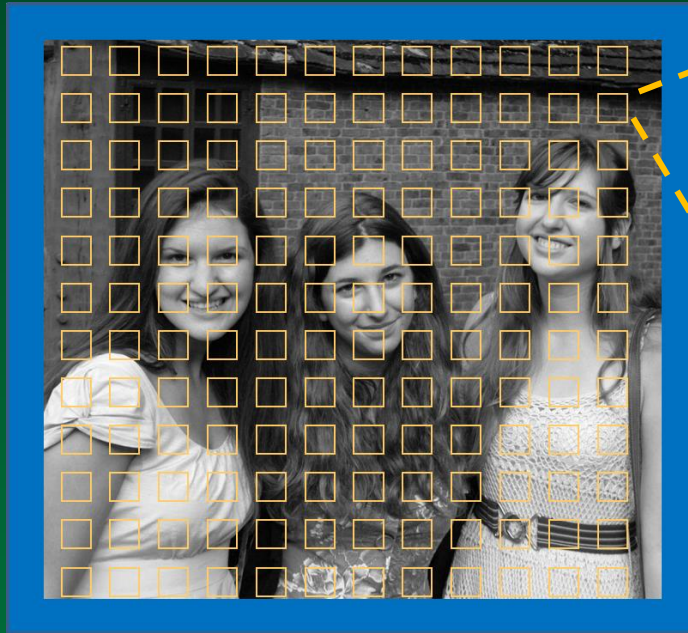


Presentation Plan

- Overview
- QIS Imaging Properties
- Jot Devices
- Readout Circuits
- Making Pixels from Jots
- Summary



Active Pixels with Intra-Pixel Charge Transfer



One
pixel



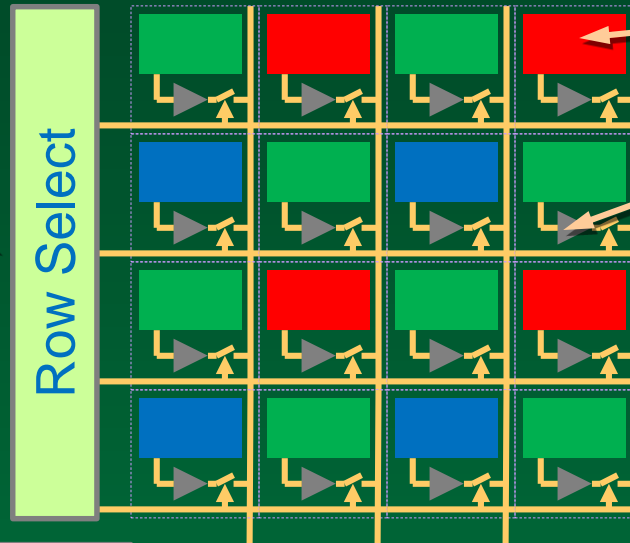
CMOS Active Pixel Sensor 2nd Generation Image Sensor

Read pixel signals out thru switches and wires

Row select logic chooses which row is selected for readout.

Timing and control logic controls the timing of the whole sensor

SoC functionality for color processing, compression, etc.



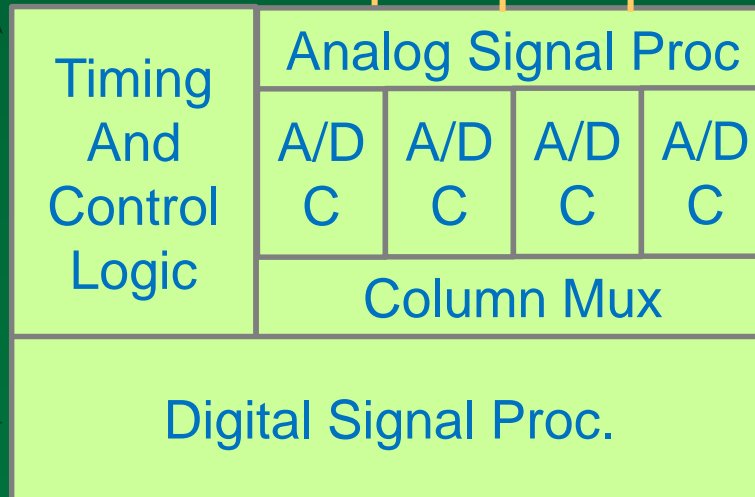
Photodetector converts photons to electrons

Amplifier converts electrons to voltage after intrapixel complete charge transfer

Analog signal processor suppresses noise and further amplifies signal

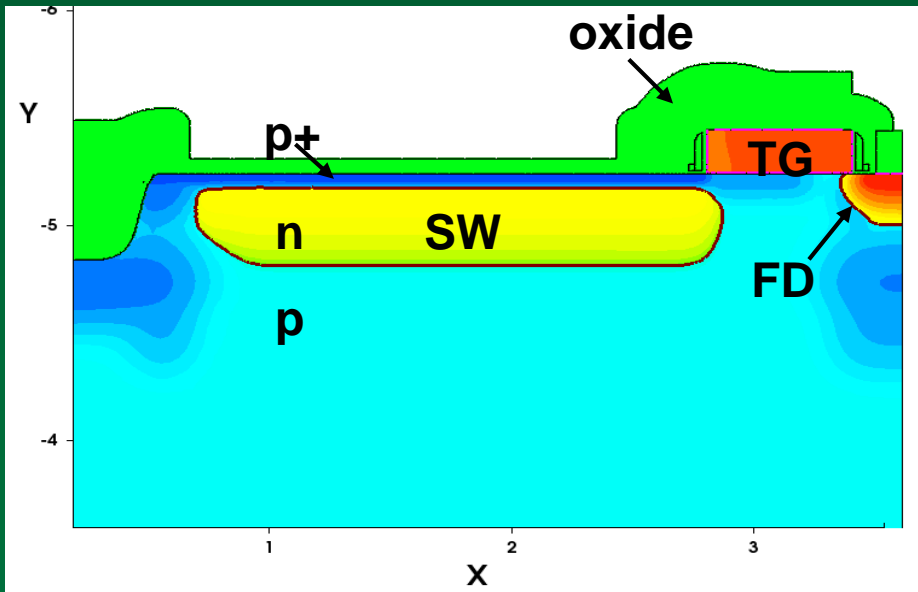
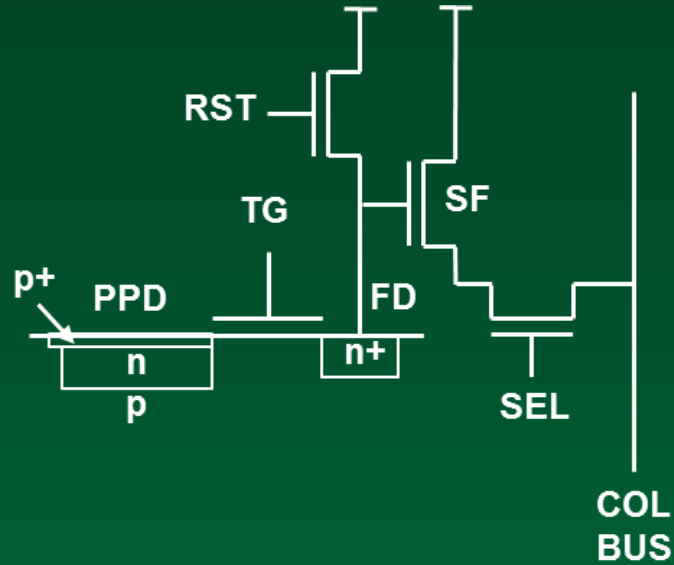
Analog-to-digital converters (ADC) convert signals from volts to bits (usually 10-12 bits resolution) in parallel

Column multiplexer used to scan ADC outputs

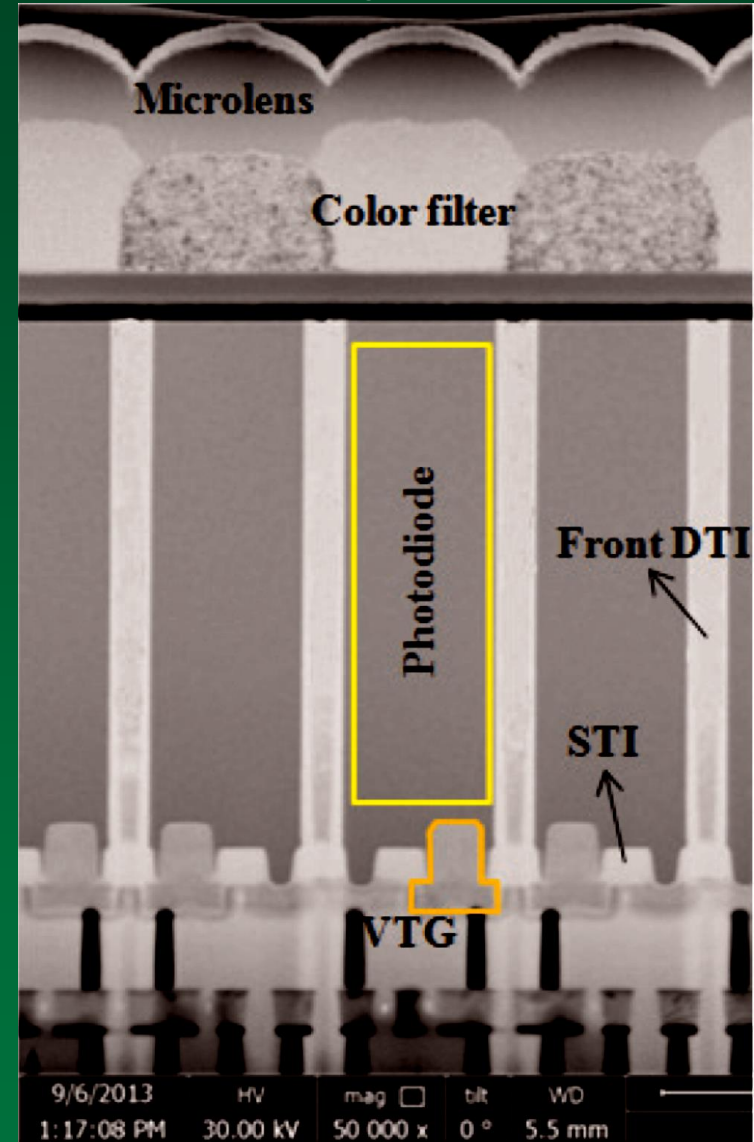




Pinned Photodiode Pixel



Samsung ISSCC 2013





Quanta Image Sensor

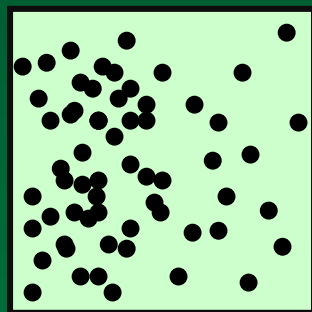
- Original goal for QIS was to take advantage of shrinking pixel size and make a very tiny, specialized pixel (“jot”) which could sense a single photoelectron.
- Jots would be readout by scanning at a high frame rate to avoid likelihood of multiple hits in the same jot and loss of accurate counting.
- Image pixels could be created by combining jot data over a local spatial and temporal region using image processing.
- The first proposed algorithm was the “digital film sensor” using a “grain” and “digital development” construct.



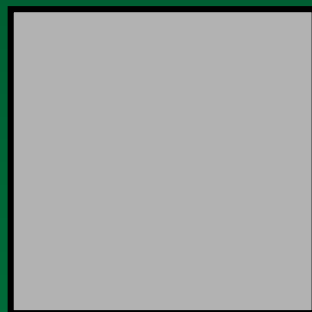
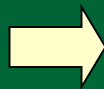
The Paradigm Shift

Current paradigm:

- We collect photons for a predetermined amount of time in a silicon “rainbucket” determined by physical size and capacity of silicon pixel.



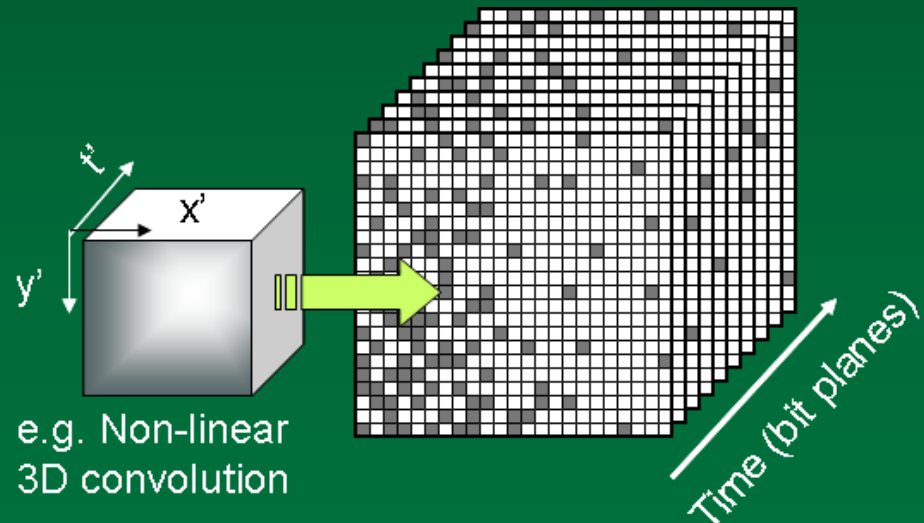
One sensor pixel



One image pixel

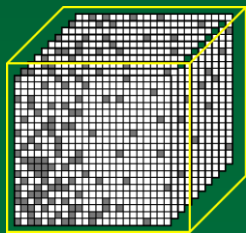
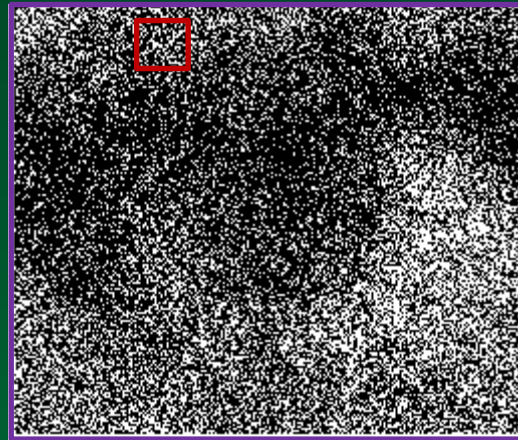
New QIS paradigm:

- Detect each photoelectron using jots, creating a binary bit plane for each time slice, and then digitally form image by digital convolution over X, Y, t





Pixels from Jots (Simulation)

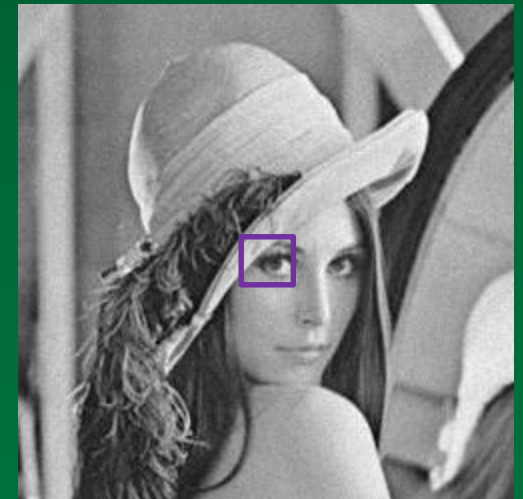


Simplest

$$\sum_{X'Y't'} j(X, Y, t)$$

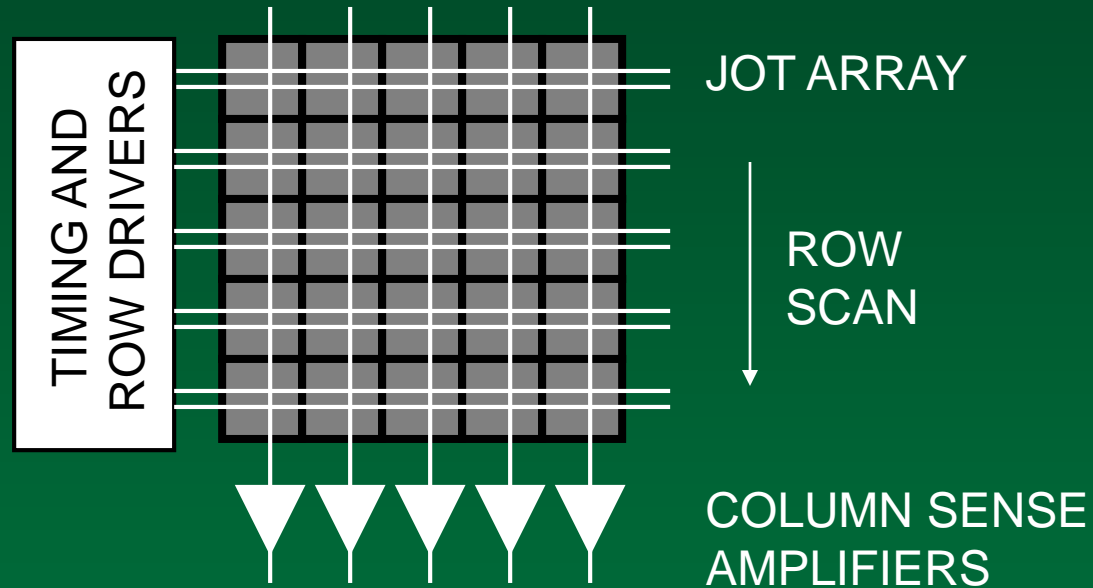
16x16x16 “cubicle”

$$0 \leq S \leq 4096$$



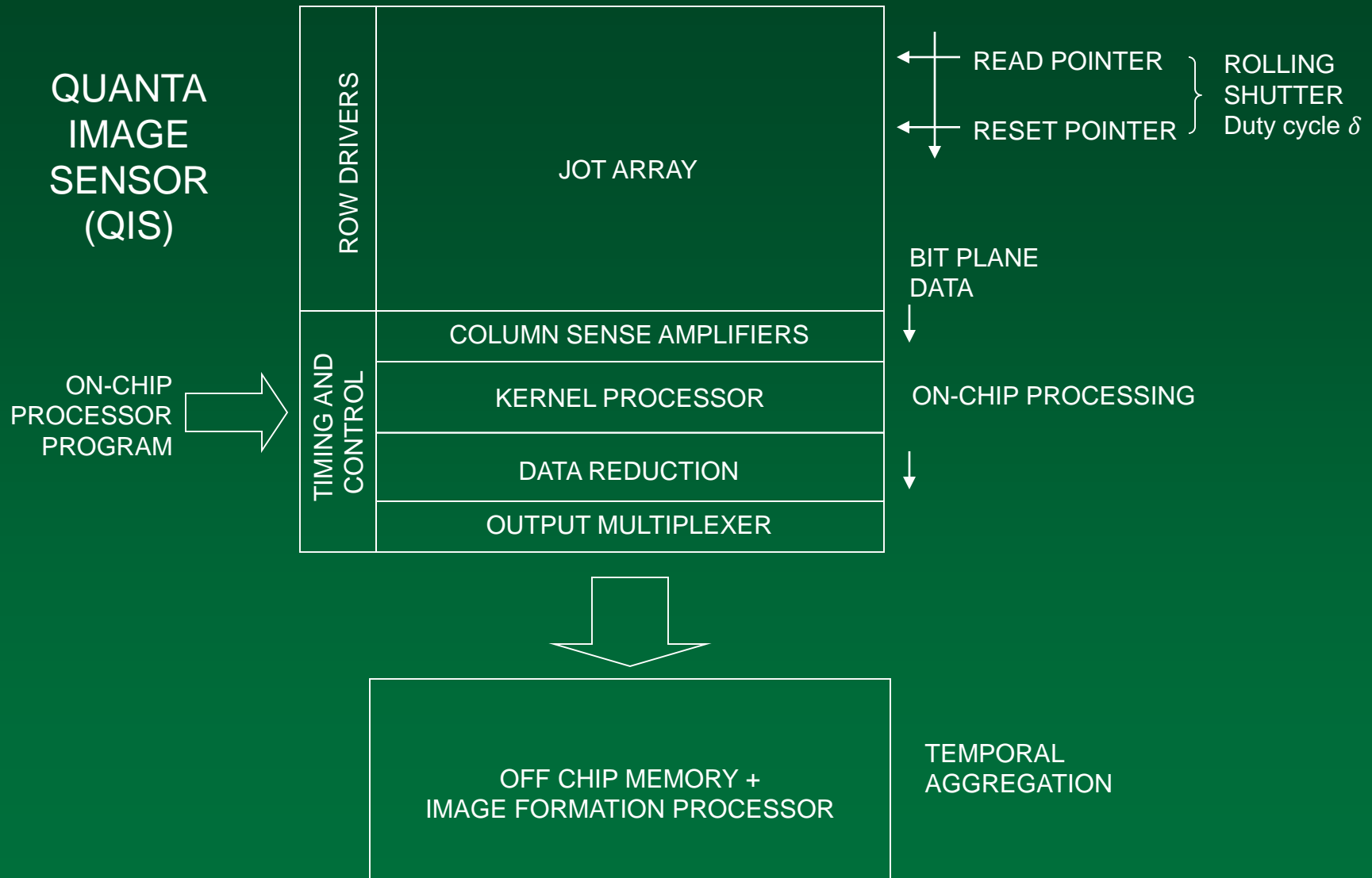


QIS Core Architecture





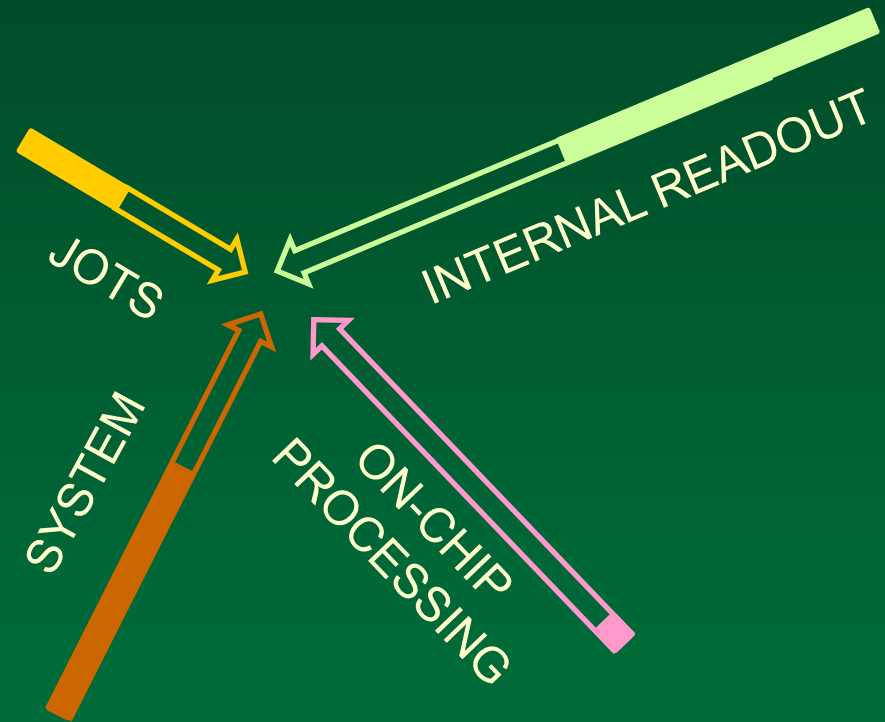
Possible Planar Architecture



QIS implementation requires Devices, Circuits, and System

Strawman numbers

- <500 nm jot pitch
- Gigajot QIS (10^9 jots)
- 1000 fps
- 1 Tb/s data rate
- 1 Watt or less (<1pJ/b)





Features and Applications

- No read noise, high resolution visible photon counting
- Flexible post-capture trade between resolution and sensitivity
- Time-delay and integration in any track direction
- Low light level imaging
- Life science imaging
- Space imaging systems
- Photography
- Motion pictures
- Security
- Defense



QIS Imaging Properties

E.R. Fossum, [Modeling the performance of single-bit and multi-bit quanta image sensors](#), IEEE J. Electron Devices Society, vol.1(9) pp. 166-174 September 2013



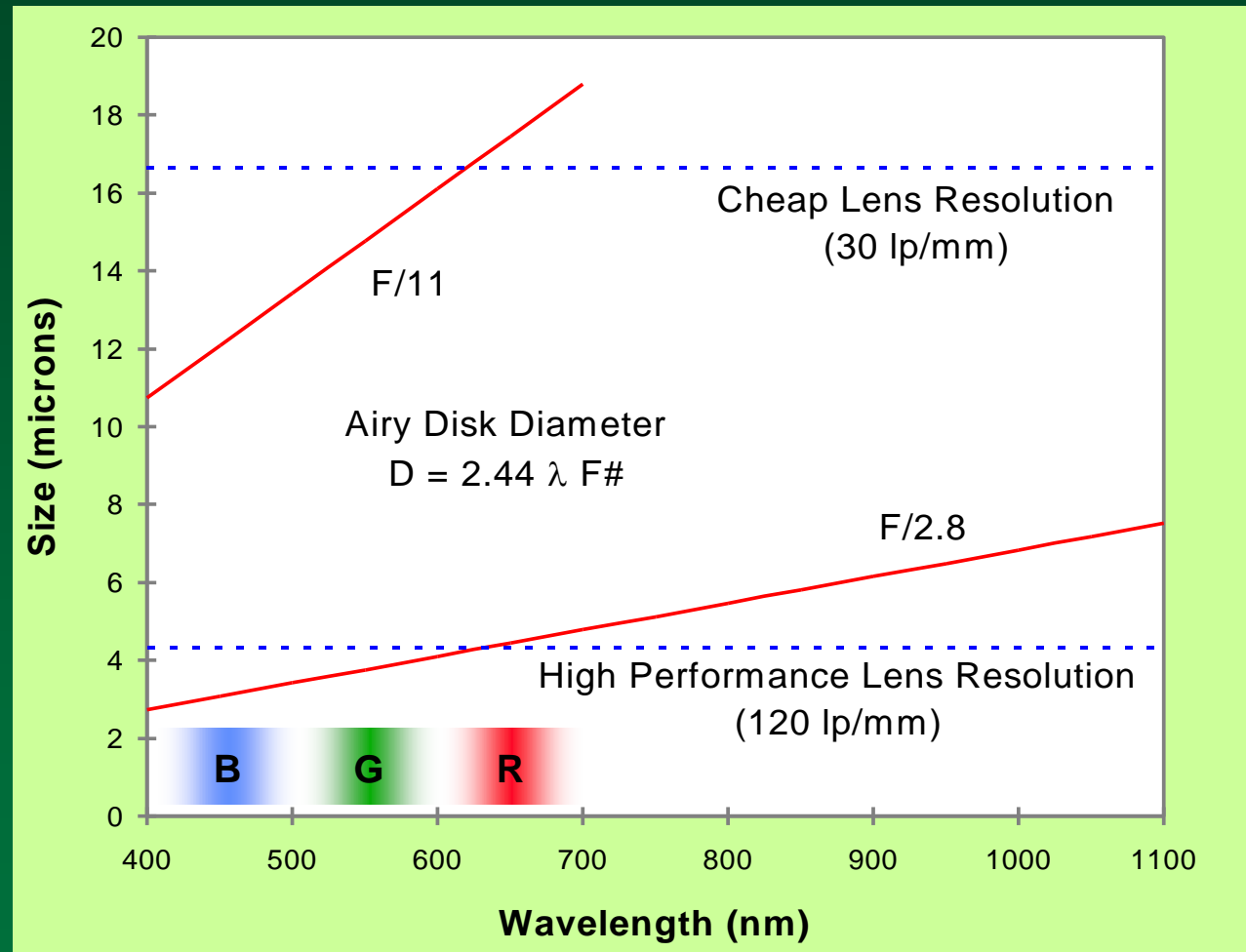
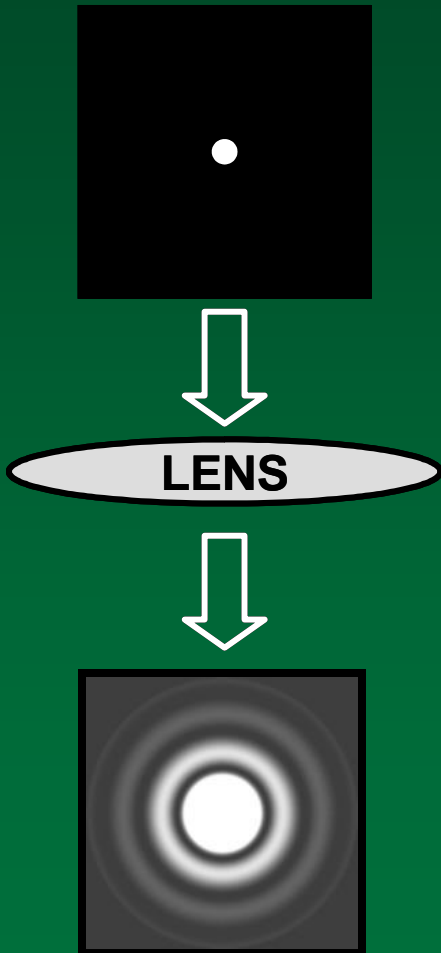
Flux Capacity

- What is the maximum photon flux that the QIS can handle (more or less)?
- At the flux capacity ϕ_{w1} , each jot, on the average, has received one photoelectron
- Let j = jot density, f_r = field readout rate, δ = shutter duty cycle, and $\bar{\gamma}$ = avg. QE

$$\phi_{w1} = jf_r / \delta \bar{\gamma}$$

- This drives high jot density and fast readout.
- Equivalency
 - 1.5 um pixel, 5000e- FWC, 1/15th sec = 33k e-/s/um²
 - 0.2 um jot, 1 e- , 1000fps = 25k e-/s/um²

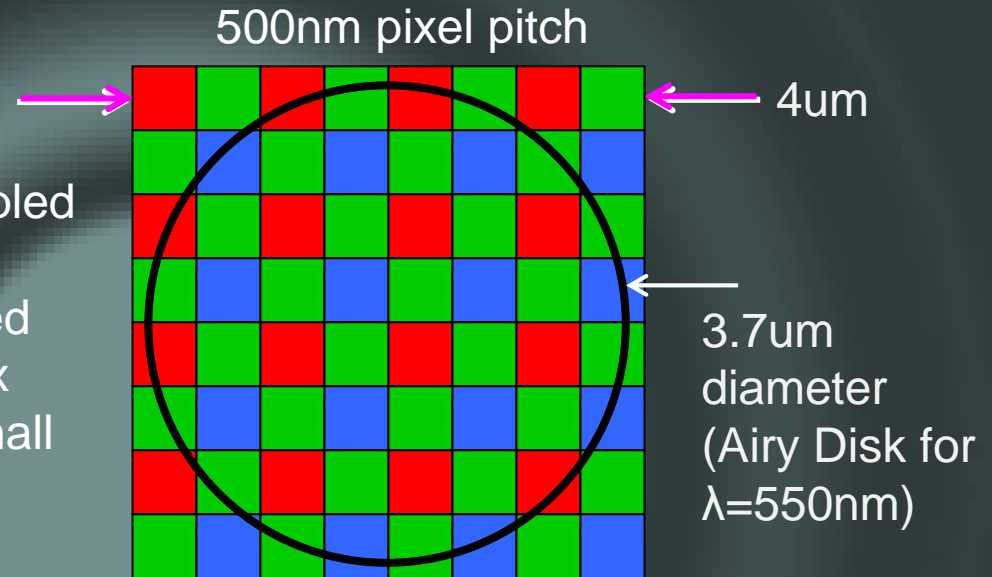
Diffraction Limit





Sub-Diffraction Limit Pixels

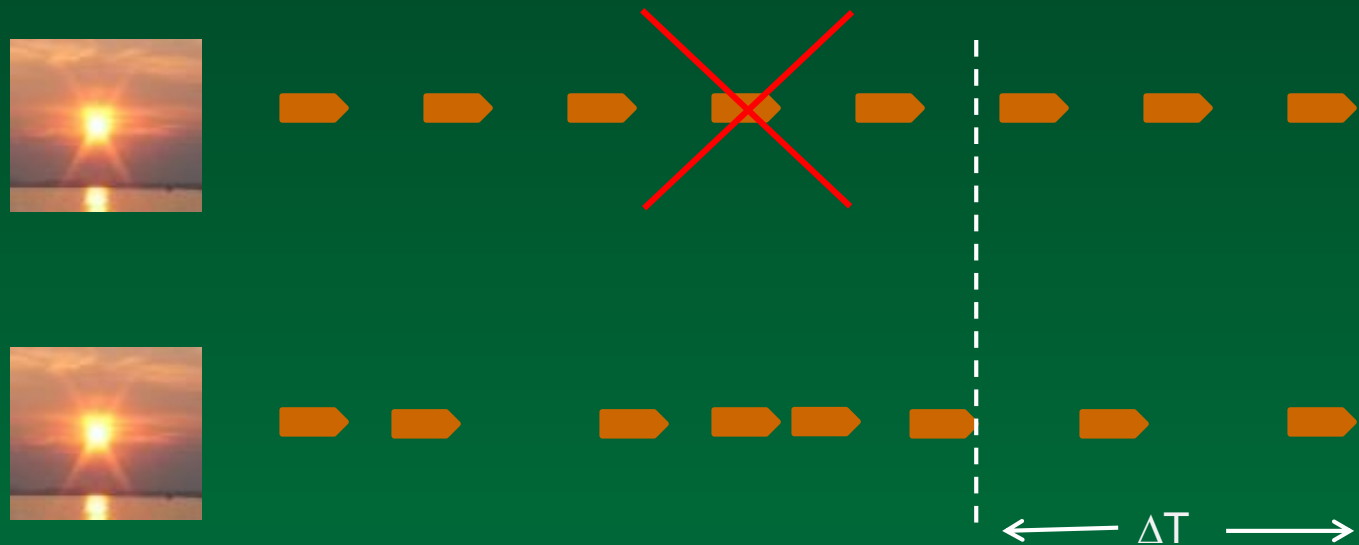
- Certainly spatially oversampled for green light at F/2.8
- Anti-aliasing filter not needed
- High jot density is about flux capacity, with only some small improvement in resolution





Photon Shot Noise

- Photon emission is a Poisson process. Stream of photons is NOT regularly spaced.



- Photon flux Φ characterized by Poisson statistics
- Variance $\langle (\Phi - \langle \Phi \rangle)^2 \rangle \sim \Phi$
- Noise $\sim \sqrt{\Phi}$ & SNR $\sim \sqrt{\Phi}$

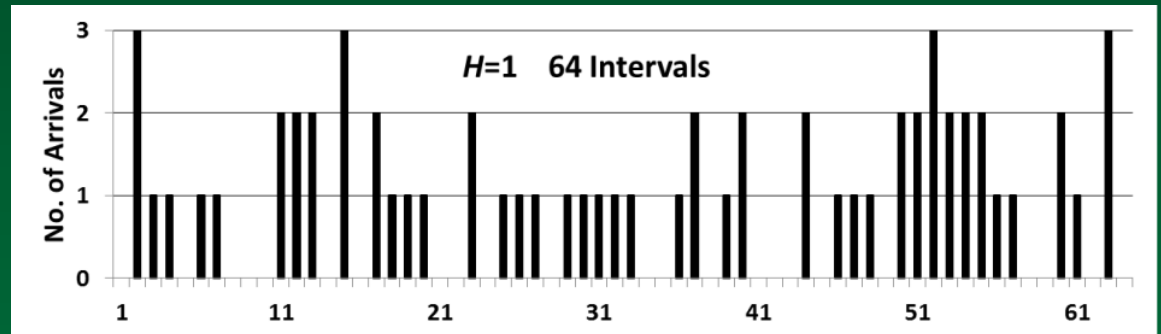
Photon and photoelectron arrival rate described by Poisson process

Define *quanta exposure* $H = \phi \tau$ $H = 1$ means expect 1 arrival on average.

Probability of k arrivals


$$P[k] = \frac{e^{-H} H^k}{k!}$$

Monte Carlo



For jot, only two states of interest

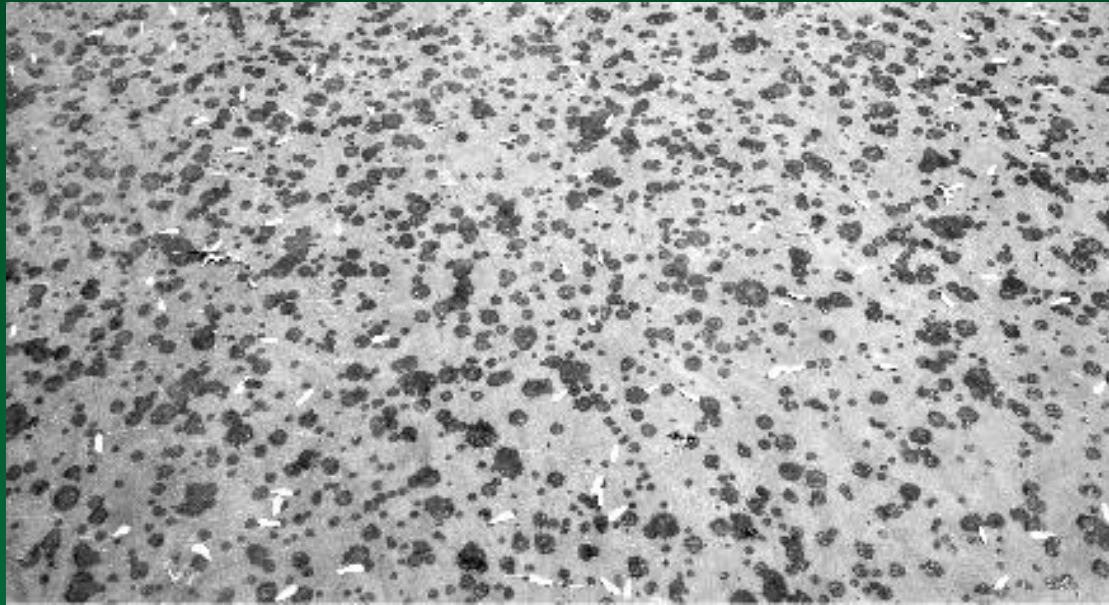

 $P[0] = e^{-H}$


 $P[k > 0] = 1 - P[0] = 1 - e^{-H}$

For ensemble of M jots, the expected number of 1's : $M_1 = M \cdot P[k > 0]$



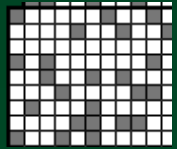
Raindrops on Ground



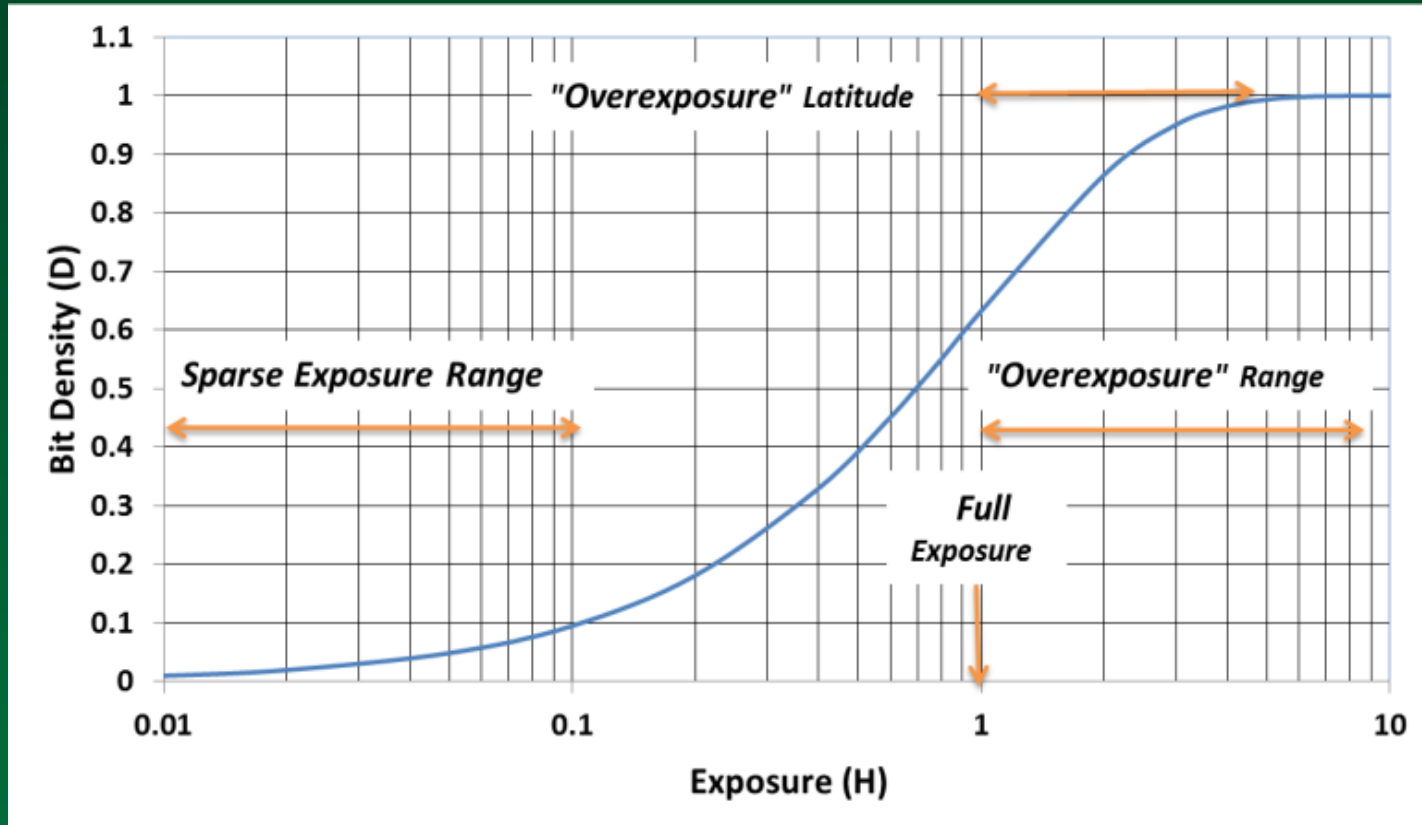
$H \sim 0.3 ?$



Bit Density



$$\text{Bit Density } D \triangleq \frac{M_1}{M} = 1 - e^{-H}$$



$$D \cong H \quad (\text{linear})$$

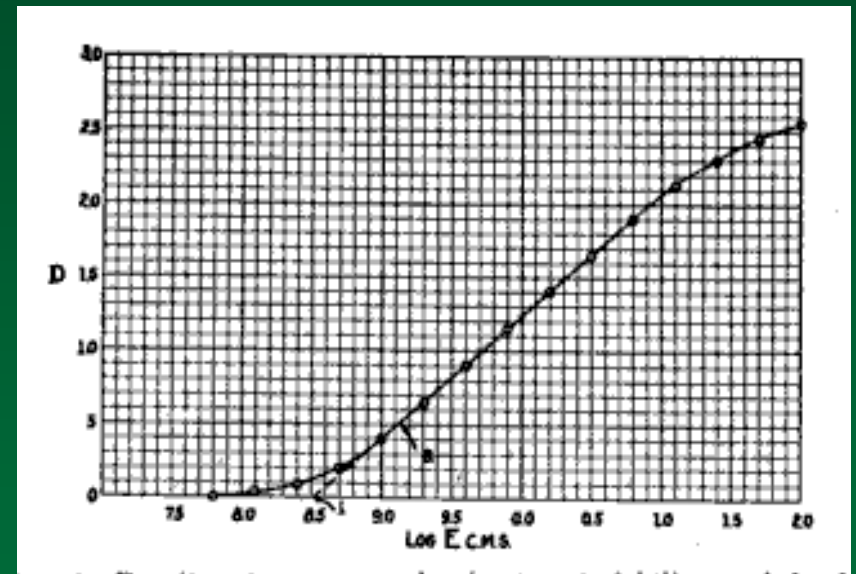
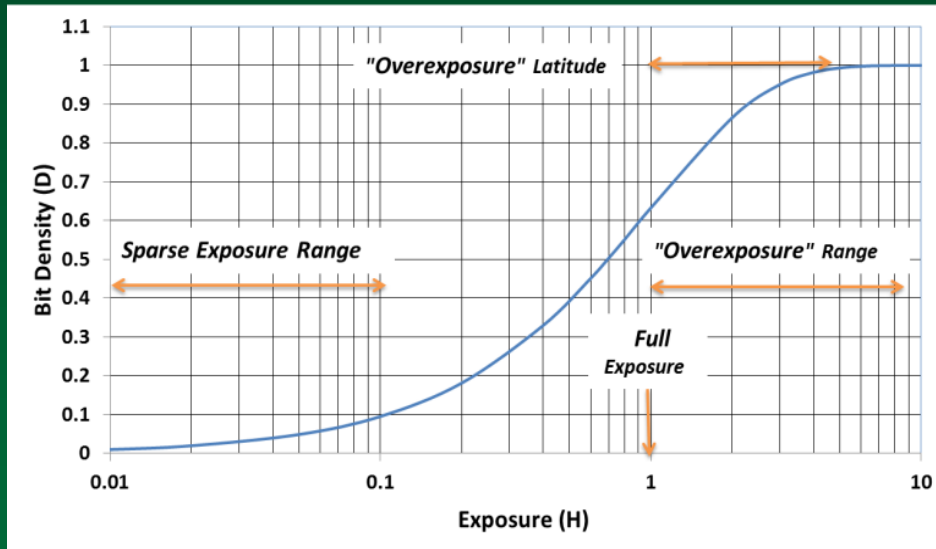
Can determine H from measured D

$$H = \ln \left[\frac{1}{1 - D} \right]$$

Film-like Exposure Characteristic

QIS D – log H

Film D – log H



Bit Density vs. Exposure

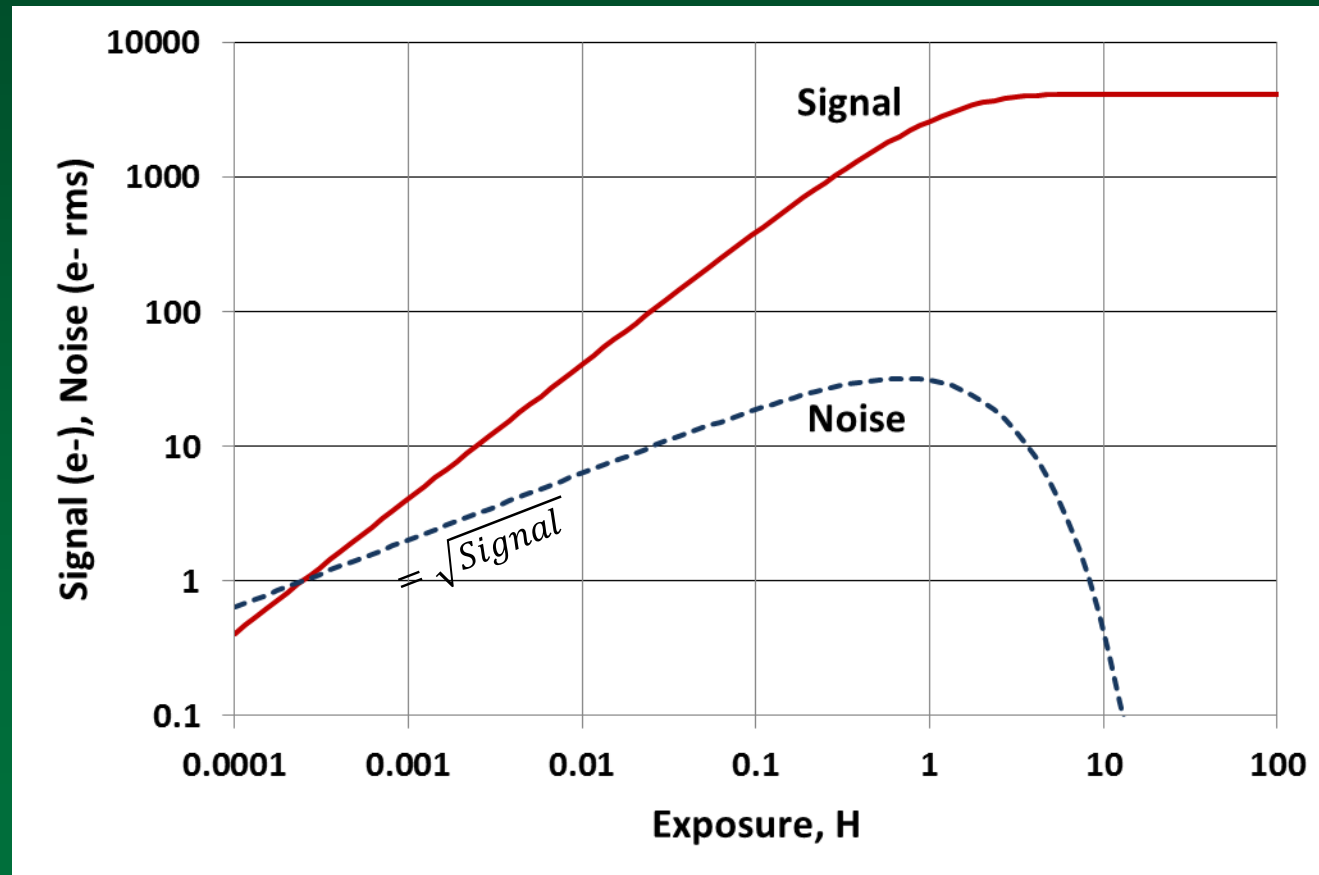
Film Density vs. Exposure
1890 Hurter and Driffield



“Shot” Noise

Variance of a binomial distribution

$$\sigma_1^2 = M \cdot P[0] \cdot P[k > 0]$$



M=4096

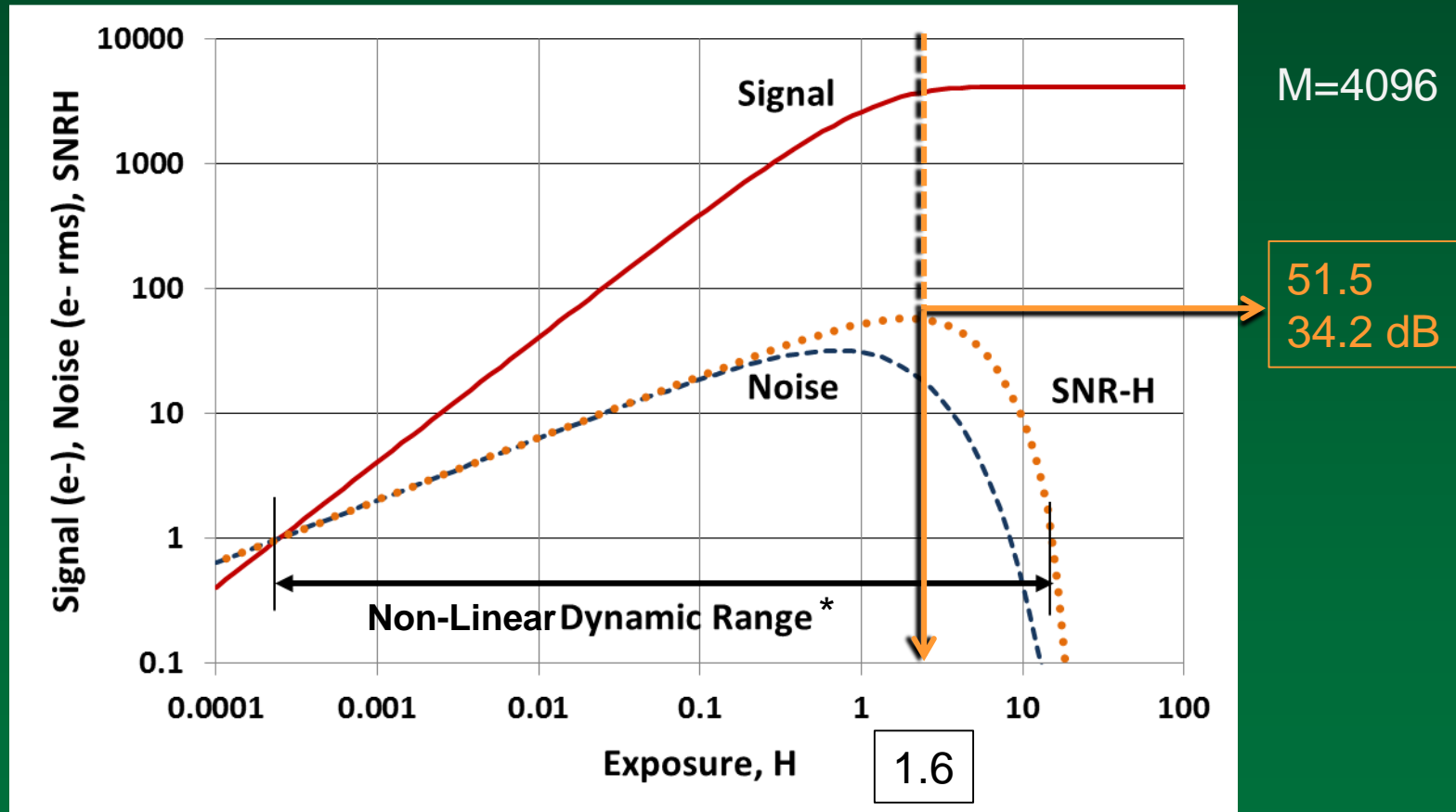
SNR $\rightarrow \infty$?



Exposure-Referred Noise

$$\sigma_H = \sigma_1 \frac{dH}{dM_1}$$

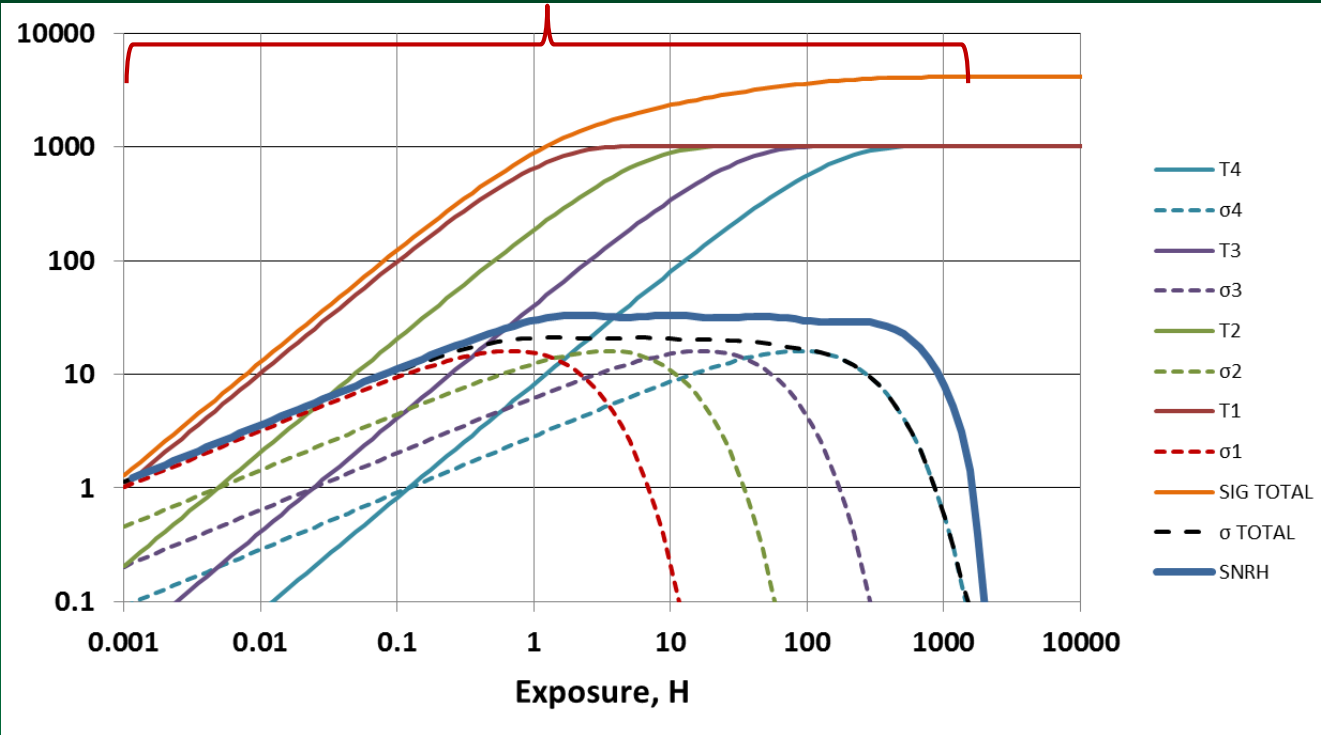
$$SNR_H = \frac{H}{\sigma_H} = \sqrt{M} \frac{H}{\sqrt{e^H - 1}}$$



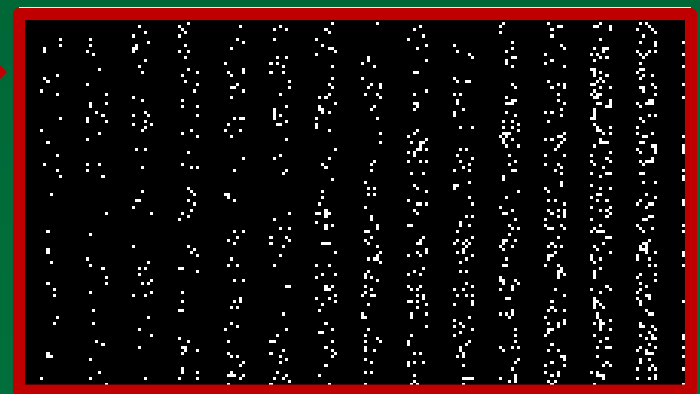
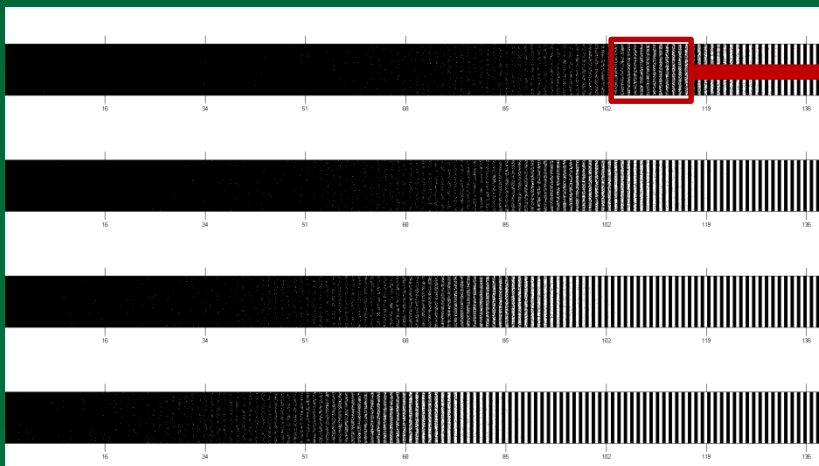


Increased Dynamic Range

>120 dB

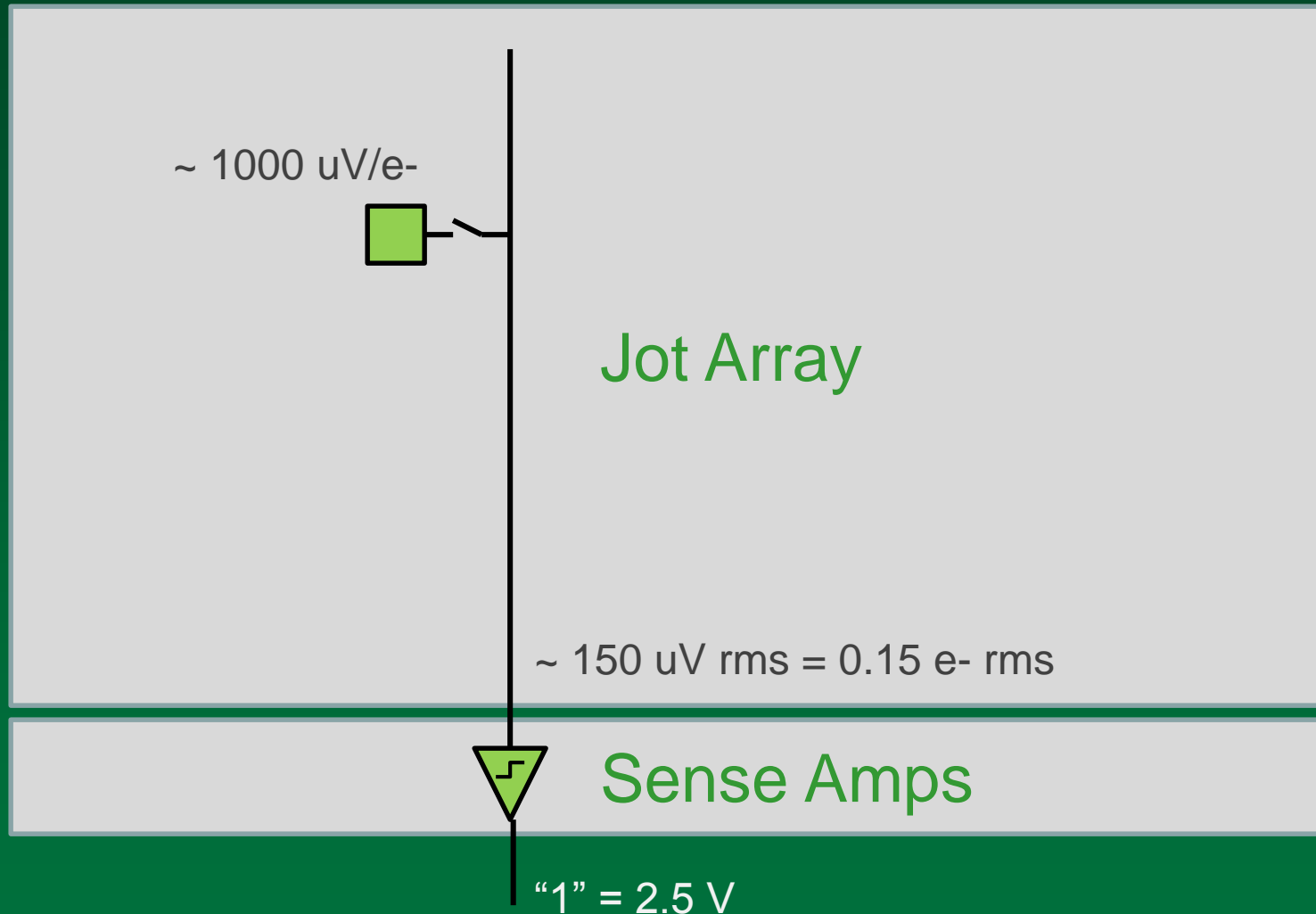


Sum of 16 fields
4 @ $\delta = 1.0$
4 @ $\delta = 0.2$
4 @ $\delta = 0.04$
4 @ $\delta = 0.008$



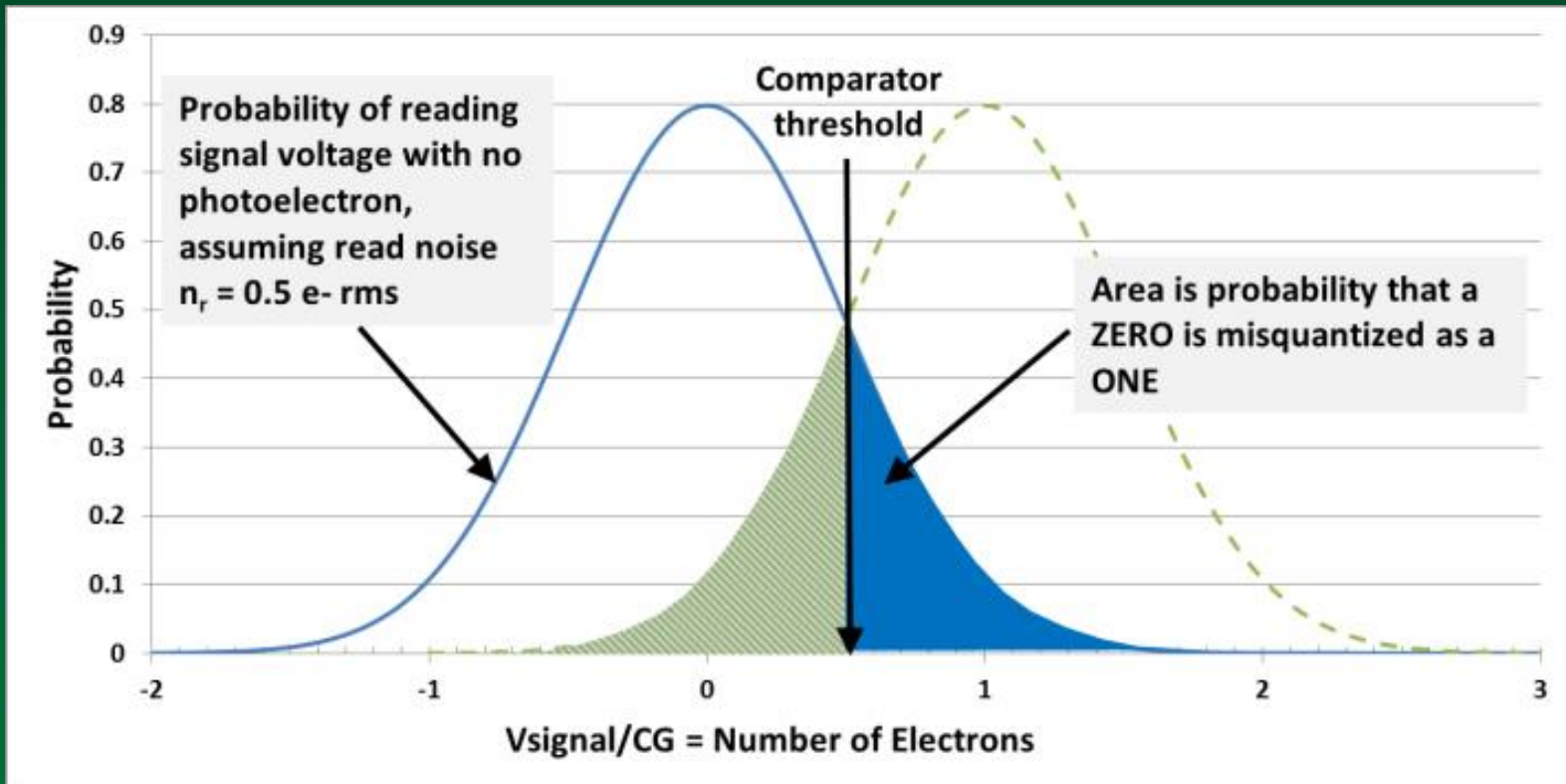


Readout Assumption for Read Noise



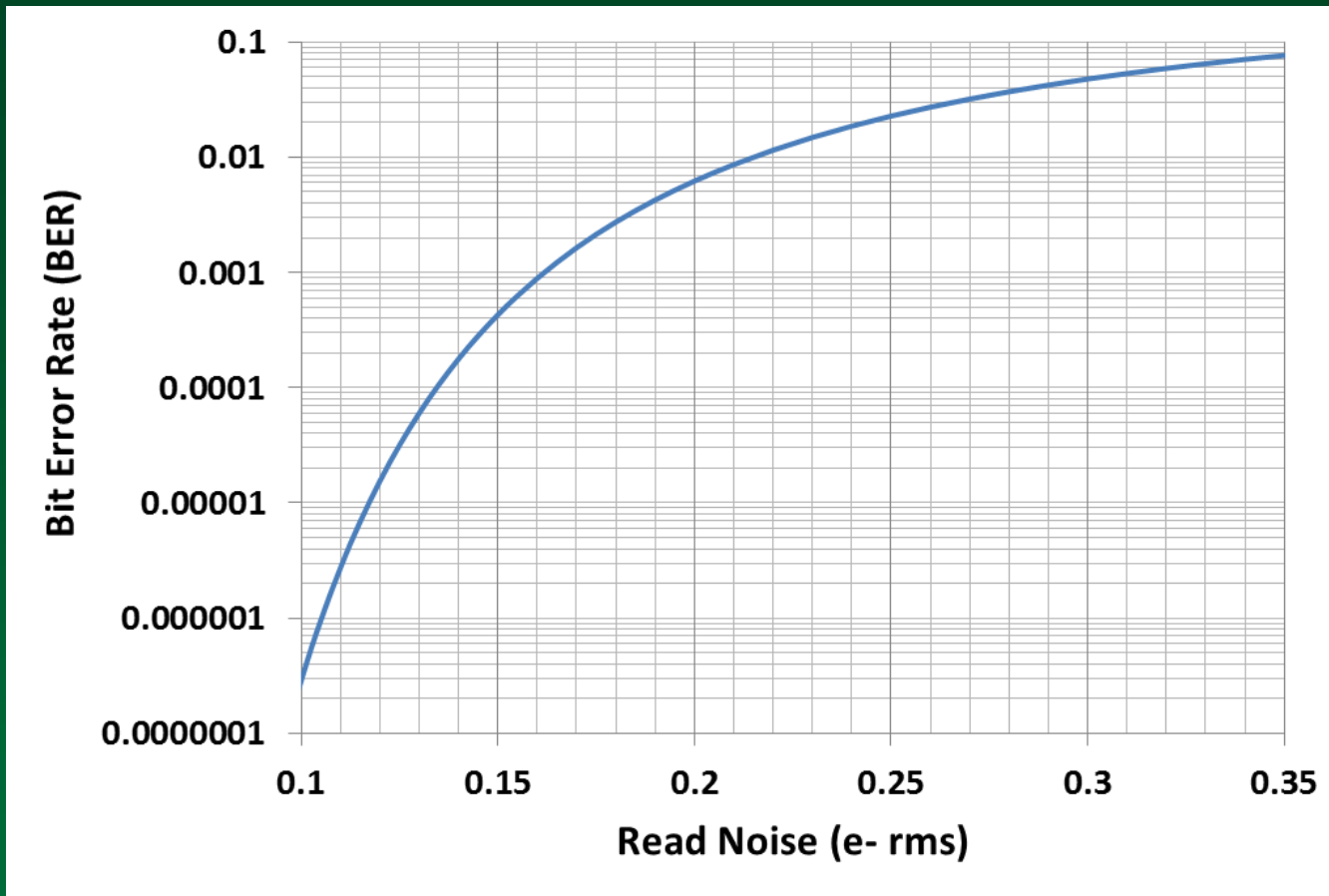


Read Noise and Bit Error Rate (BER)





BER vs. Read Noise

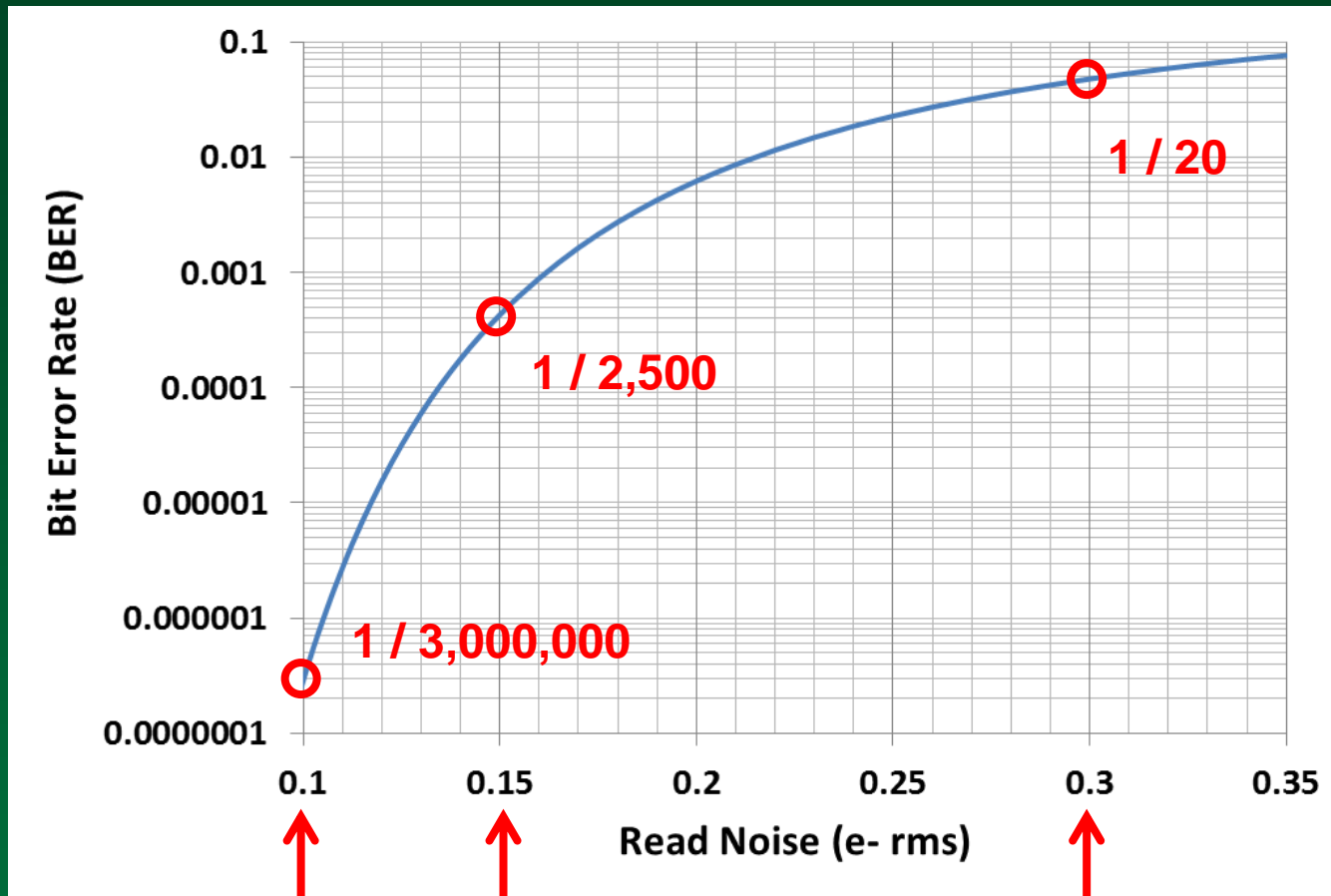


$$BER = \frac{1}{2} \operatorname{erfc} \left(\frac{1}{\sqrt{8n_r}} \right)$$

What is an acceptable bit error rate?



BER vs. Read Noise



Fossum 2011
WAG

Fossum
2013

Teranishi
2012



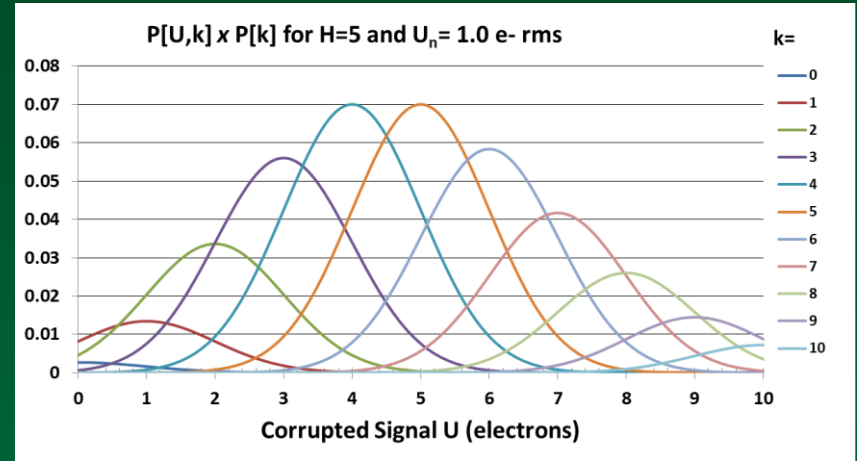
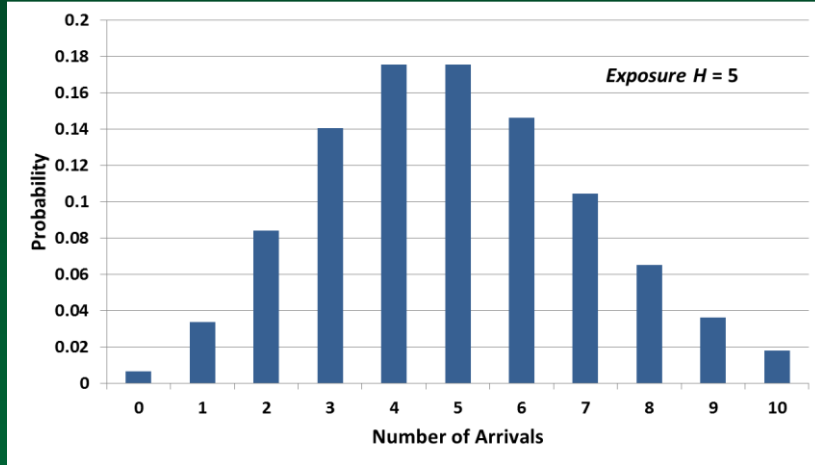
Shot Noise and Read Noise

“Shot” Noise

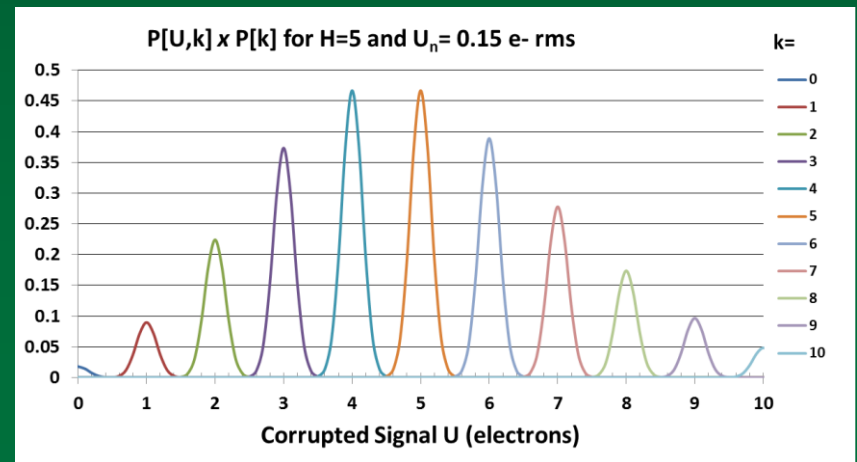
$$\sigma^2 = \langle k^2 \rangle - \langle k \rangle^2$$

plus

Read Noise
(Gaussian model)

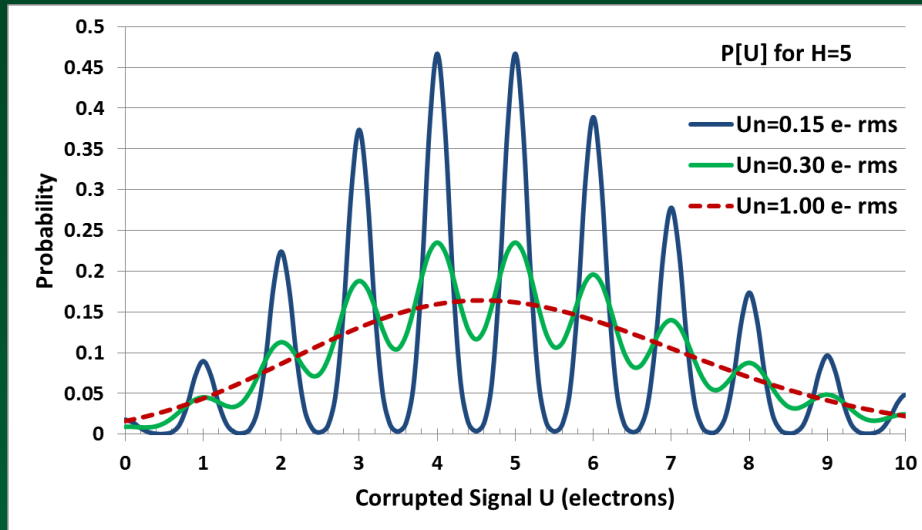


$$P[k] = \frac{e^{-H} H^k}{k!}$$

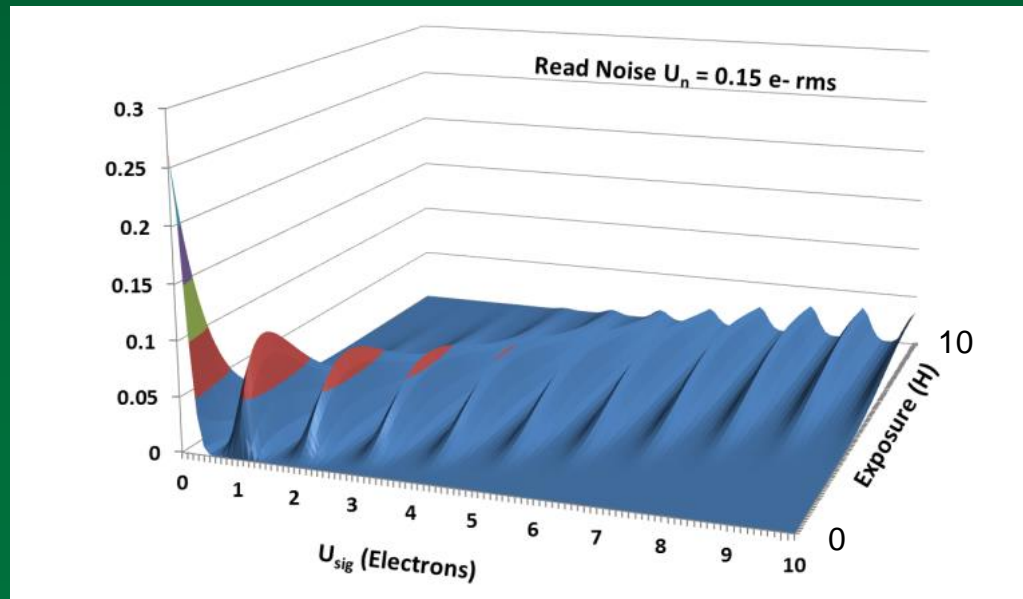




Effect of Read Noise on Photoelectron Counting for Multi-bit Pixel



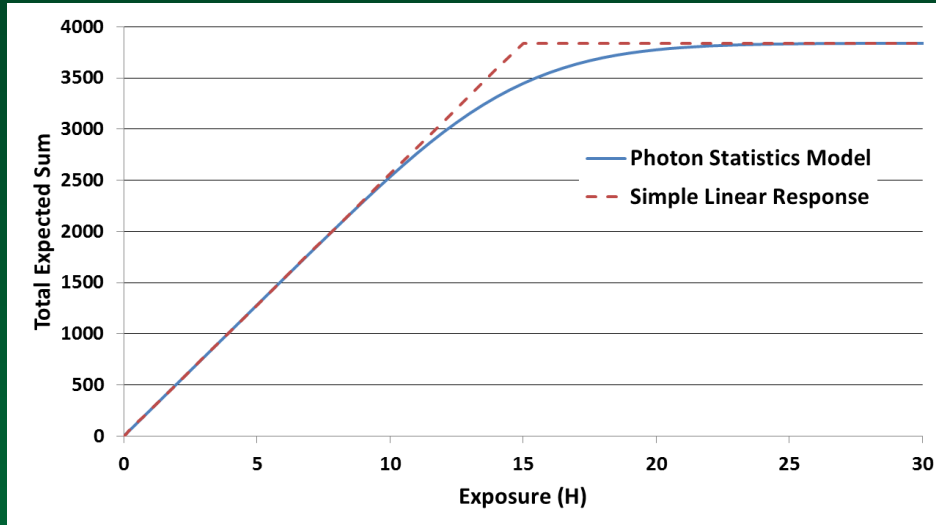
Note “peak” for $H=5$ is not at 5 e-





Multi-bit Pixels

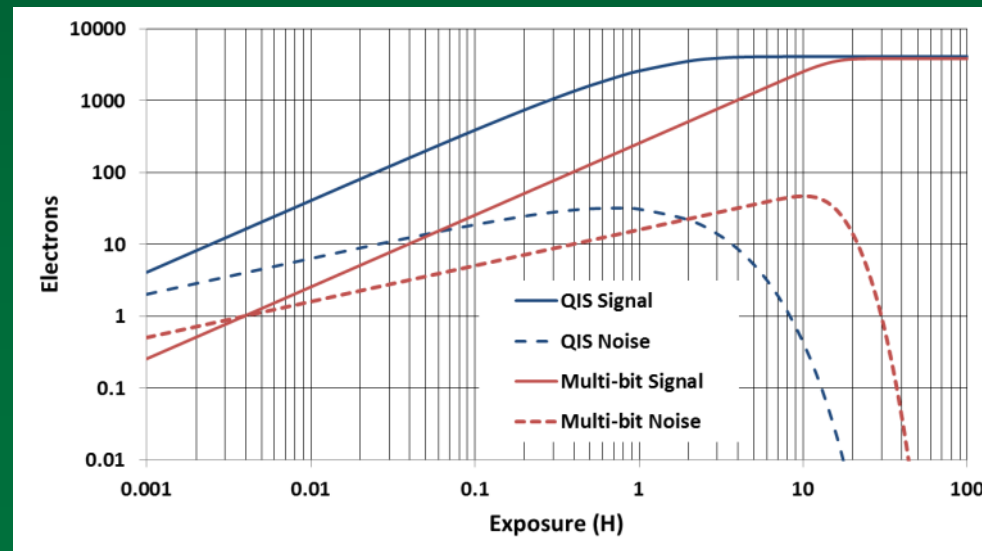
Counting low number of photoelectrons, e.g. 4b yields $FW = 15 e^-$



Sum $4 \times 4 \times 16 = 256$ pixels
Max = $15 \times 256 = 3840$

$$\phi_{wn} = j f_r (2^n - 1) / \delta \bar{\gamma}$$

QIS: $M=4096$
4b: $M=273$



1b v. 4b



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AT DARTMOUTH

Jots

Jiaju Ma, Donald Hondongwa and E.R. Fossum



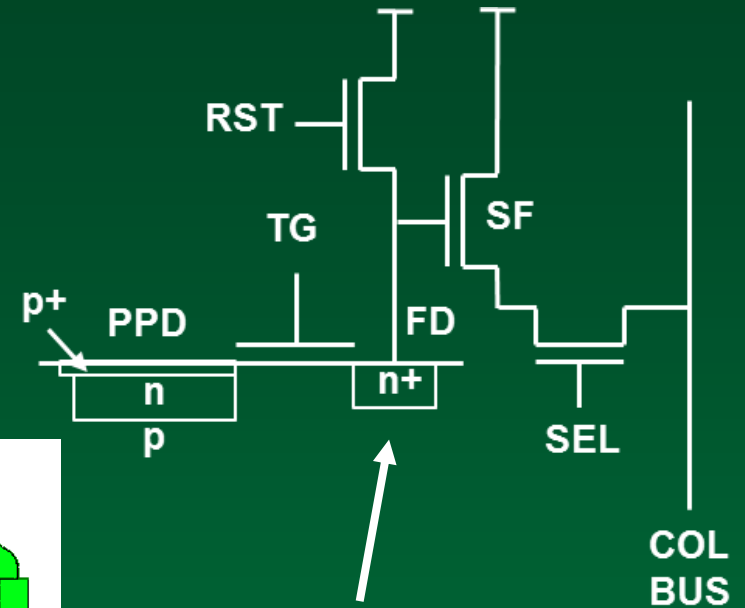
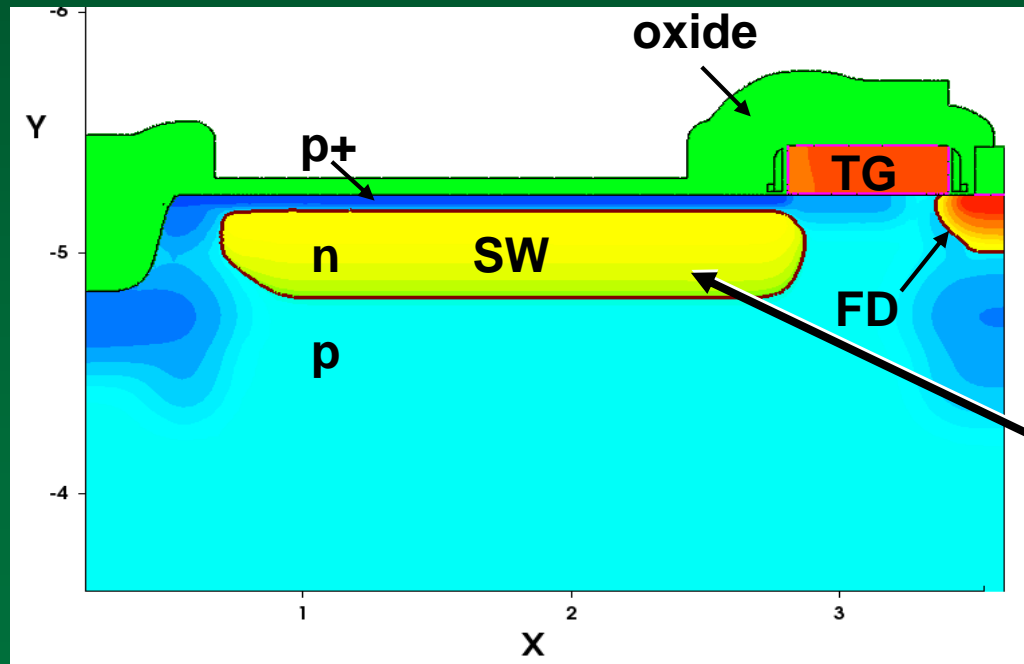
Jot Device Considerations

General targets:

- 200 nm device in 22 nm process node (“10L”)
- High conversion gain $> 1 \text{ mV/e}^-$ (per photoelectron)
- Small storage well capacity $\sim 1\text{-}100 \text{ e}^-$
- Complete reset for low noise
- Low active pixel transistor noise $< 150 \text{ uV rms}$
- Low dark current $\sim 1 \text{ e}^-/\text{s}$
- Not too difficult to fabricate in CIS line



Pinned Photodiode Pixel

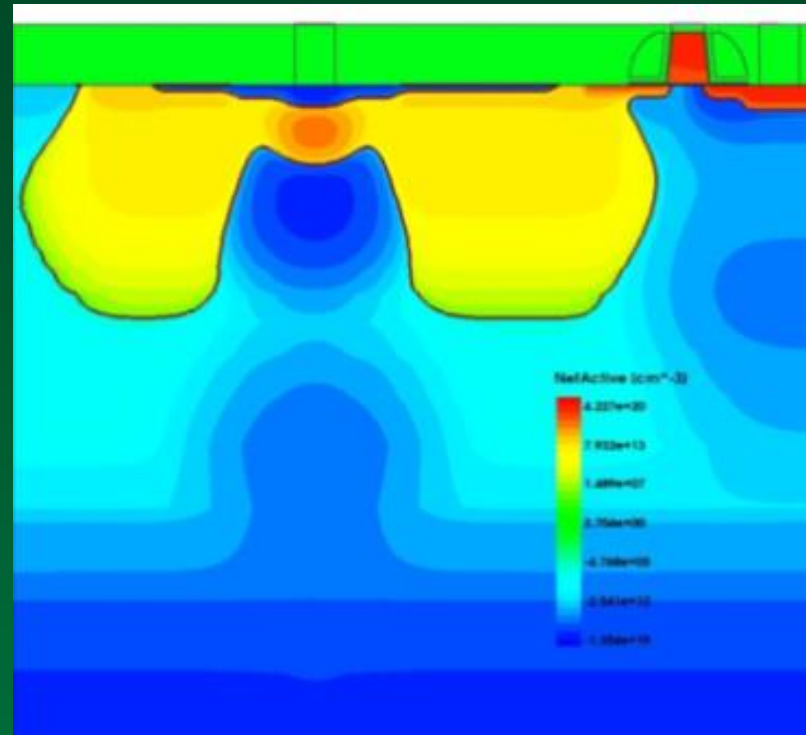
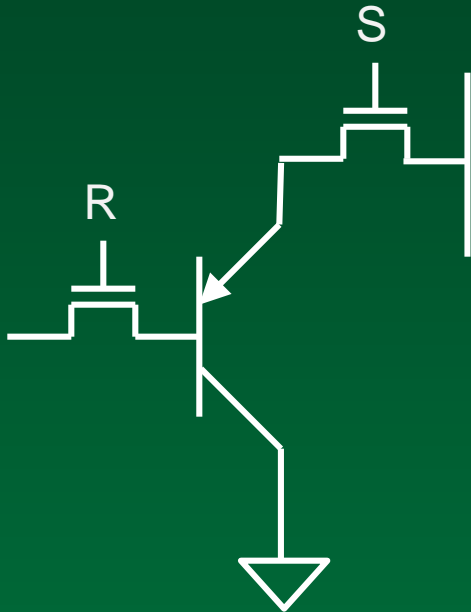


Typ. 50-100uV/e-

Typ. 3-5ke-/um²



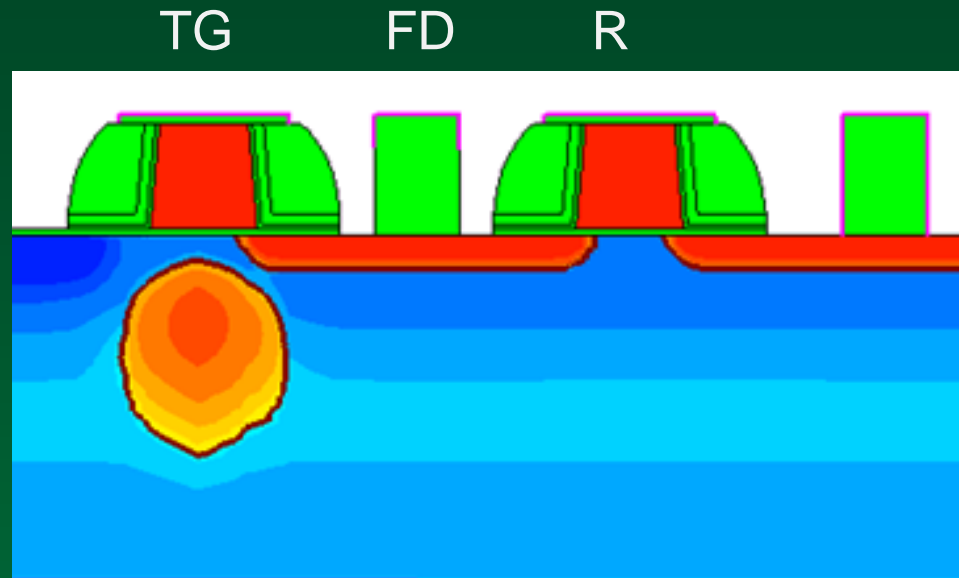
Bipolar Jot Concept



- CMOS APS but use pinning layer as emitter, storage well as base
- Complete reset of base using “TG”
- Emitter follower to reduce base-emitter cap



BSI CMOS APS Jot with Storage under Transfer Gate



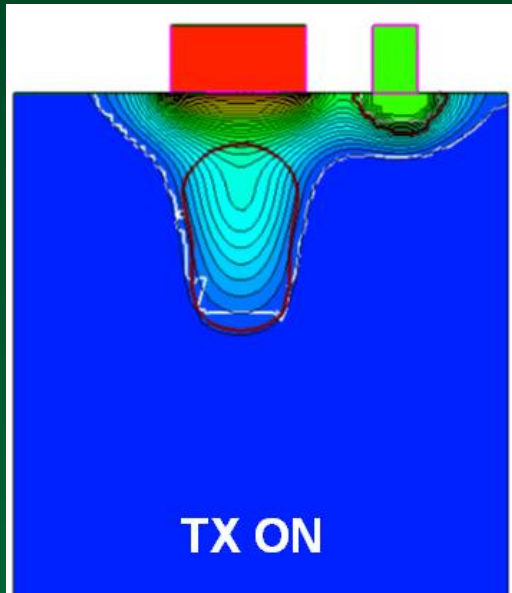
Ma and Fossum 2013

- Low capacity storage gate makes barrier easier to overcome with low TG voltage
- Minimum FD size to increase conversion gain

Storage under transfer gate first proposed in
Back Illuminated Vertically Pinned Photodiode with in Depth
Charge Storage, by J. Michelot, et al., 2011 IISW



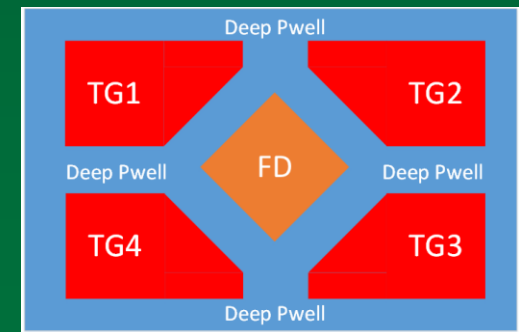
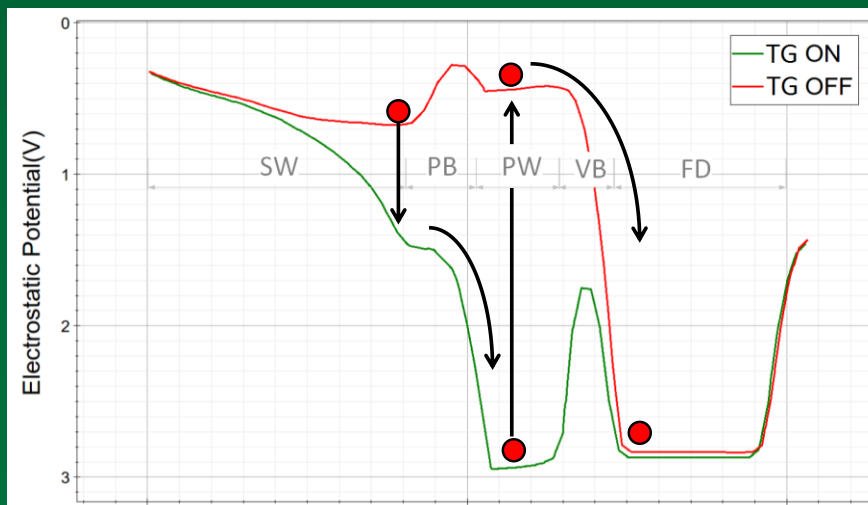
Pump-gate Jot Device with Distal FD to Increase Conversion Gain



(Simulation)

- 65 nm node
- 1.4 μm pitch
- 3.3 V operation
- 200 e- FW
- 480 $\mu\text{V}/\text{e}^-$

Test array taped out
Summer 2014 incl.
shared readout



© E.R. Fossum 2014



SEFET

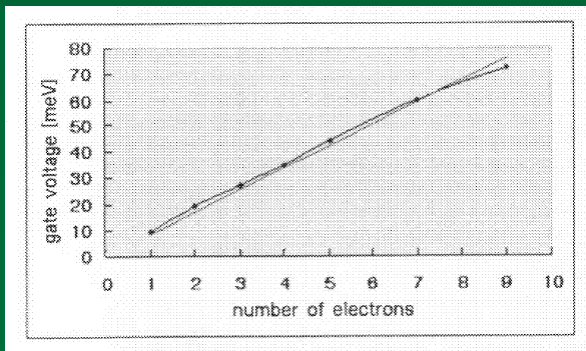
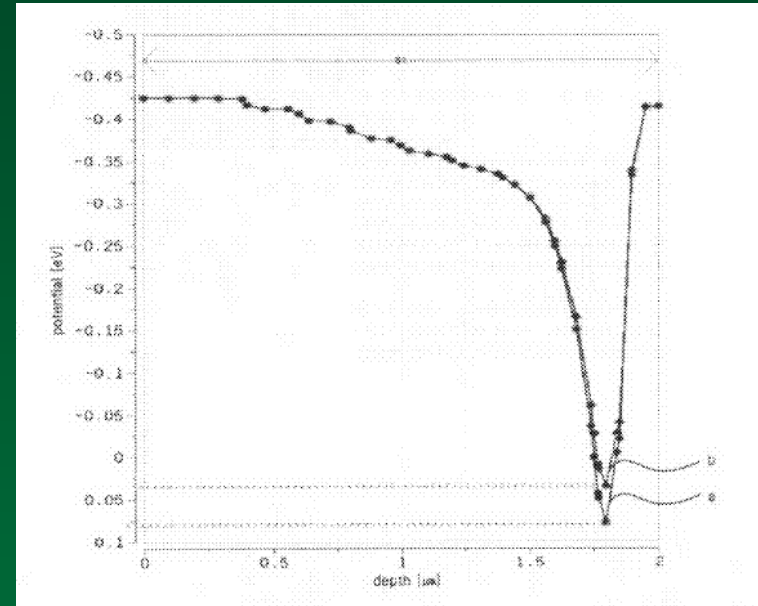
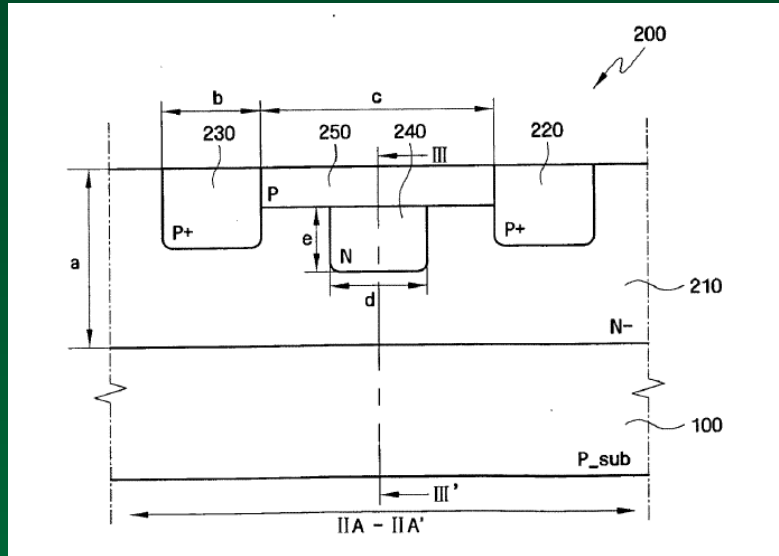
Samsung

(19) United States

(12) Patent Application Publication
Fossum et al.

(10) Pub. No.: US 2010/0320515 A1
(43) Pub. Date: Dec. 23, 2010

US 20100320515A1



Status:

- TCAD model only
- Shows about 5 mV/e- signal
- More work required

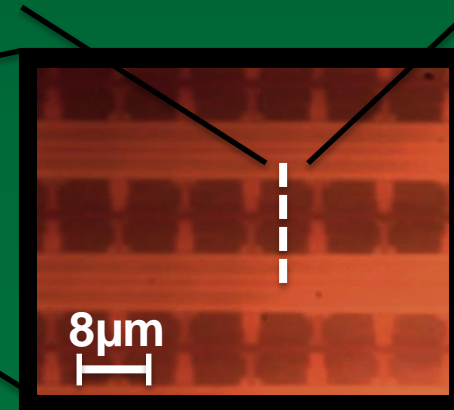
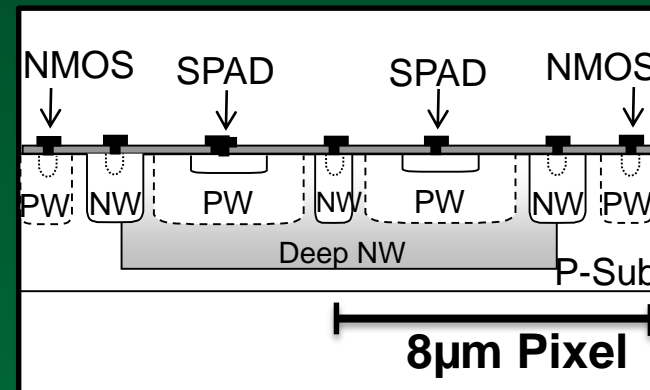
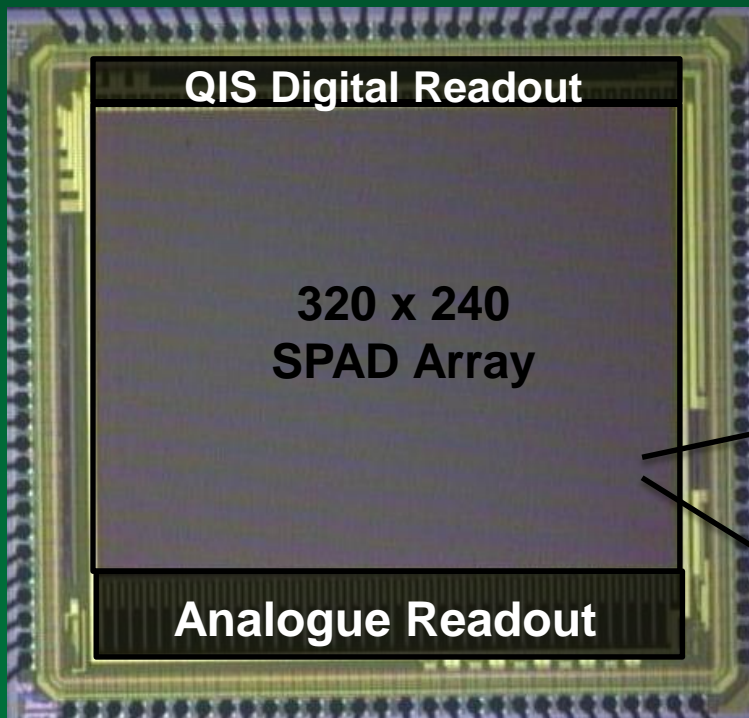


SPAD Implementation of QIS At Univ. Edinburgh



320x240 SPAD-based QIS

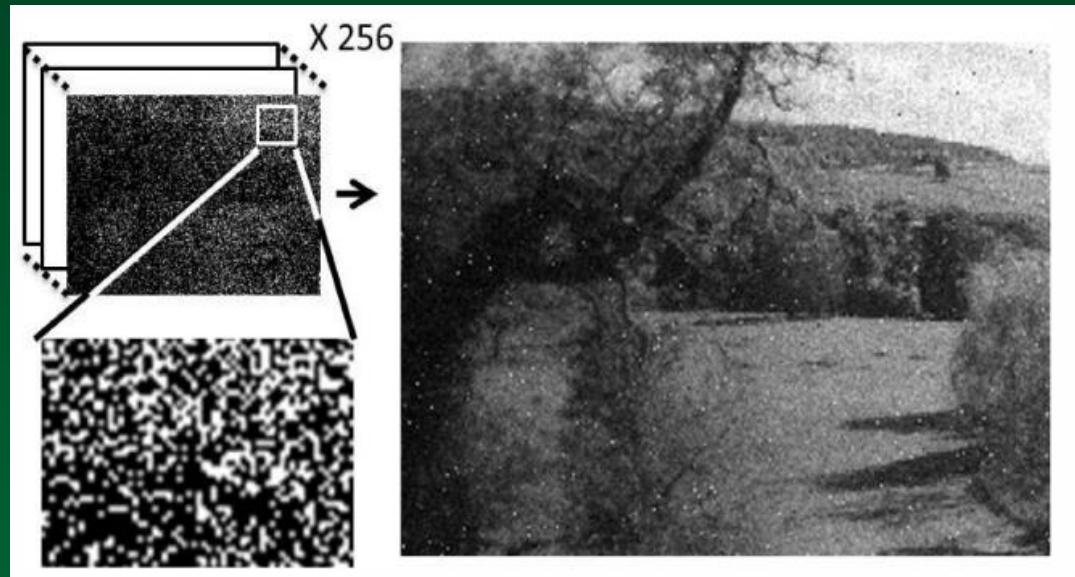
- Dutton et al. *IEEE VLSI Symposium* 2014
- University of Edinburgh & ST Microelectronics
- 8 μ m SPAD-based Pixel with 26.8% FF





320x240 SPAD-based QIS

Dutton et al. *IEEE VLSI Symposium* 2014



5k FPS Binary Frames  20 FPS 8b DR (256 frames summed)

	SPAD-QIS	Desired QIS
Flux Capacity ϕ_{w1}	21 e-/s/um ²	20,000 e-/s/um ²
Energy/bit	166 pJ/b	<1 pJ/b



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Readout of Jot Signal to Digital Circuits

Saleh Masoodian, Arun Rao, Song Chen, Kofi Odame and E.R. Fossum



Readout Signal Chain Strawman Design

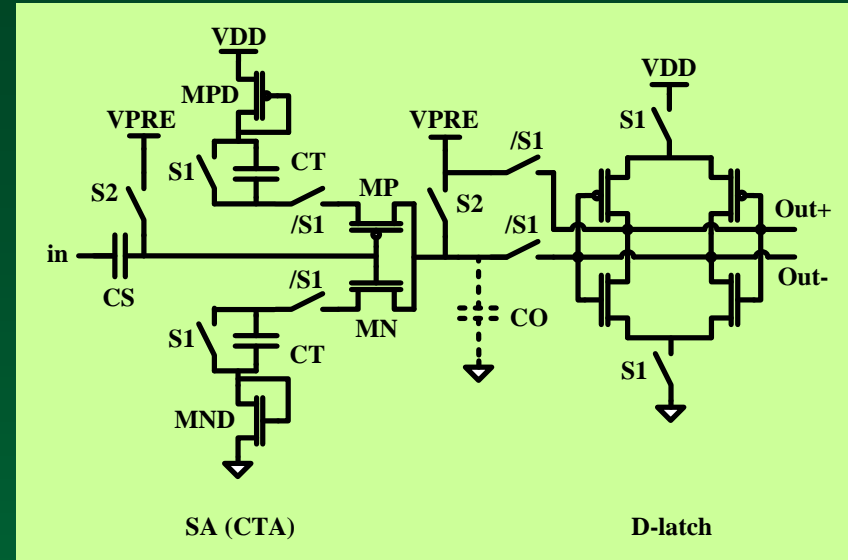
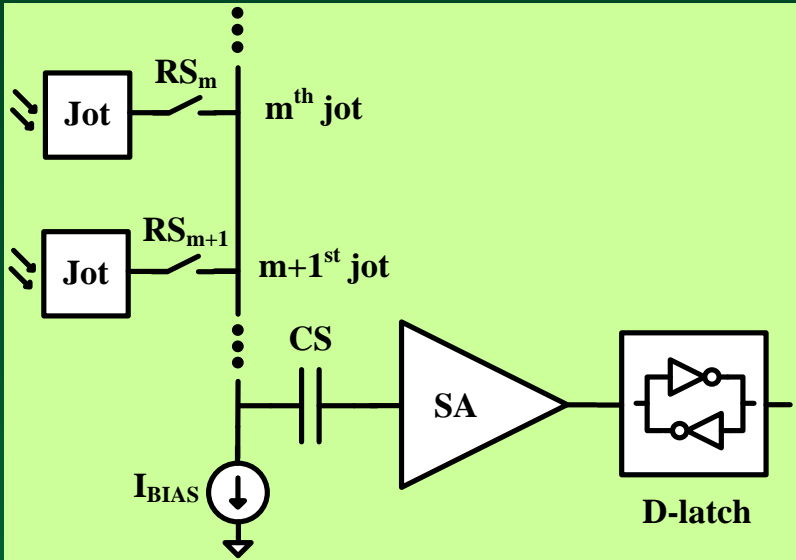
General requirements:

- Need to scan 0.1-10 Gjots at 100-1000 fields per sec
- 8k – 80k jots per column → 0.8 – 80M jots/sec

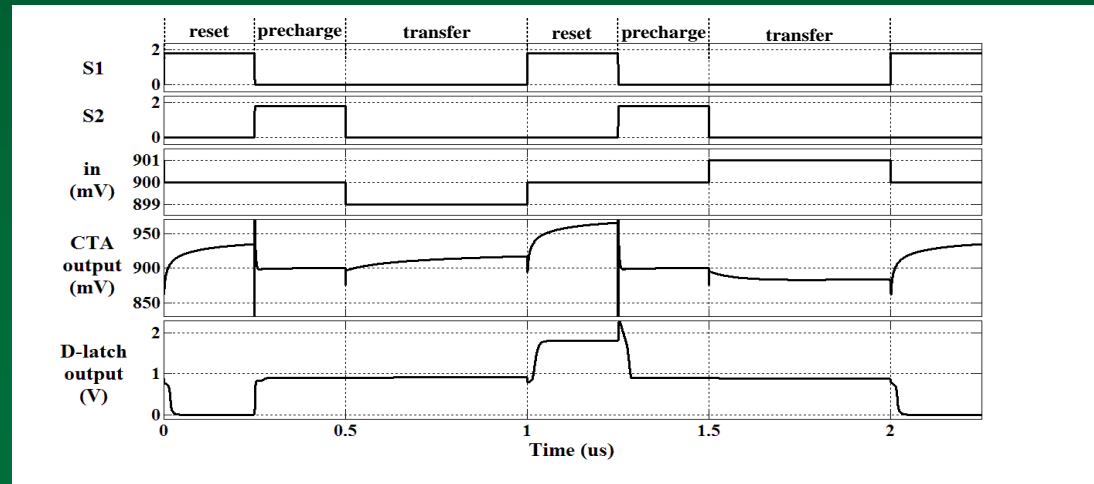
Assumptions:

- 0.1 Gjot at 100 fps → 1Mjot/sec
- 1 mV/e⁻ conversion gain
- 150 μ V rms noise on column bus (0.15 e⁻ rms)
- 0.18 μ m process
- V_{dd} = 1.8V

Low Power Sense Amp



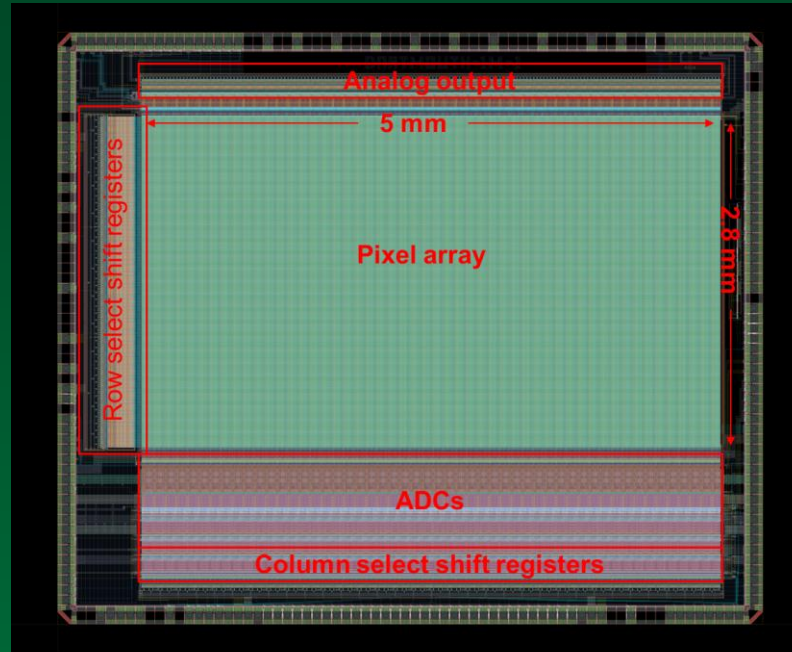
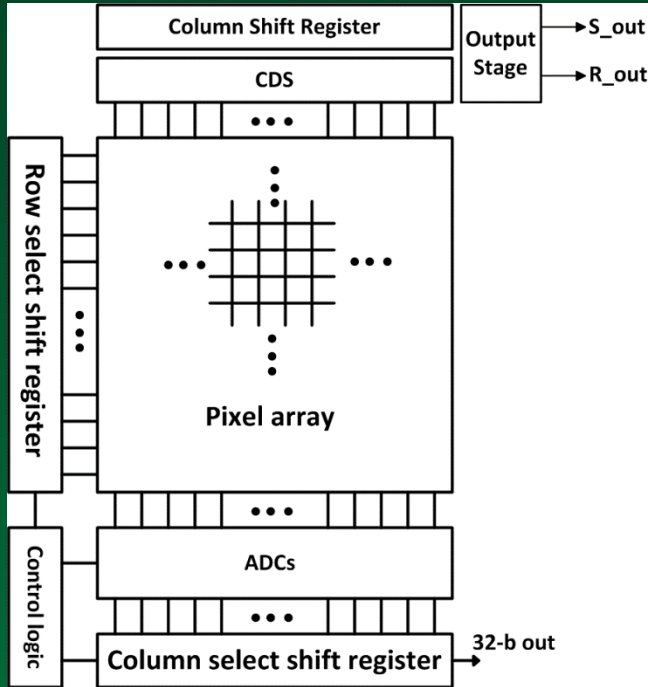
- XFAB 0.18um
- Vdd 1.8V
- 1000"jot"/col
- I_{bias} ~ 1uA
- 1MSa/s
- Power 2uW
- Energy 2pJ/jb



S. Masoodian, K. Odamé, and E.R. Fossum, [Low-power readout circuit for quanta image sensors](#), Electronics Letters, Vol. 50 No. 8 pp. 589–591 April 2014.



23mW 1000fps 1 Mpix binary image sensor



1 captured frame, $\lesssim 5e-$

- XFAB 0.18um 1.8V
- 1376(H) x 768(V) 3.6um 3T CDS
- 200uV/e- (sim)
- 768KSa/s
- 1 Gb/s data rate
- Whole chip incl. pads 23mW
- ADCs 5.6mW
- Energy 5.3pJ/b



65nm pathfinder for 1 Giga jot at 1000fps

- 1Gjot imager might be 42,000(H) x 24,000(V)
- Limited space for Dartmouth on multi-project chip on multiproject wafer so only 32 columns
- There are 24,000 pixels in each column.
- Power consumption per column is multiplied by 42,000 to get the power consumption of a 1Gjot imager.



65nm pathfinder for 1 Giga jot at 1000fps

Process	65nm, 1P5M		
VDD	1.2V (Analog), 2.5V (Array)		
Pixel type	4-shared PPD, 1.75T/pixel		
Pixel pitch	1.4um		
Array	32(H) X 24000(V)		
Frame rate	1000fps		
Column noise	< 150uV		
ADC sampling rate	24MSa/s		
ADC input referred offset	<500uV		
Output data rate	32 (output pins) X 24 Mb/s		
Estimated Power (Binary imager) 0.6 pJ/b		One column	1Gjot (42K column)
	Array	50uW	2.1W
	ADC	15uW	0.63W

Taped out July 2014

Single Bit v. Multi-bit

Single Bit

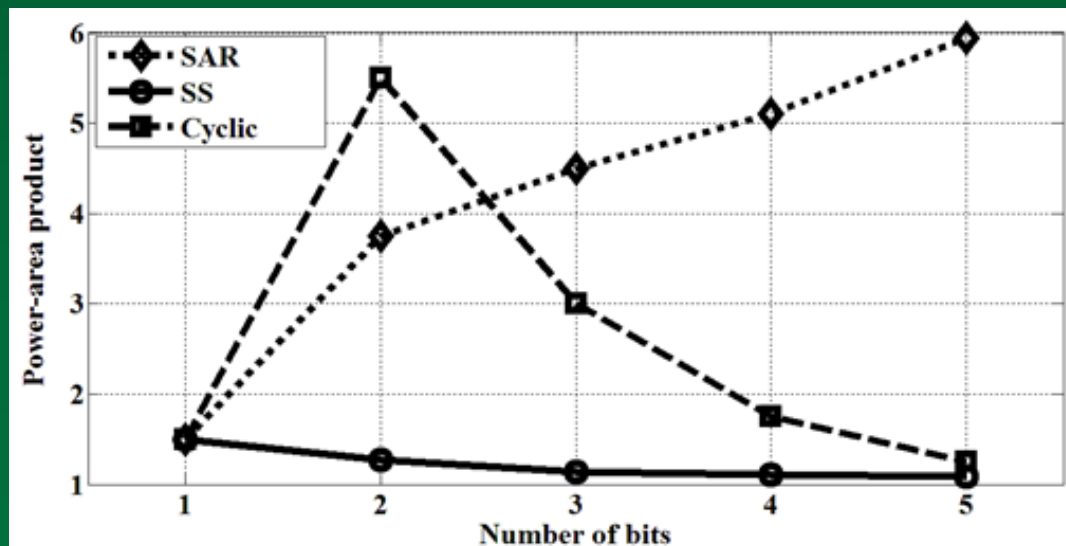
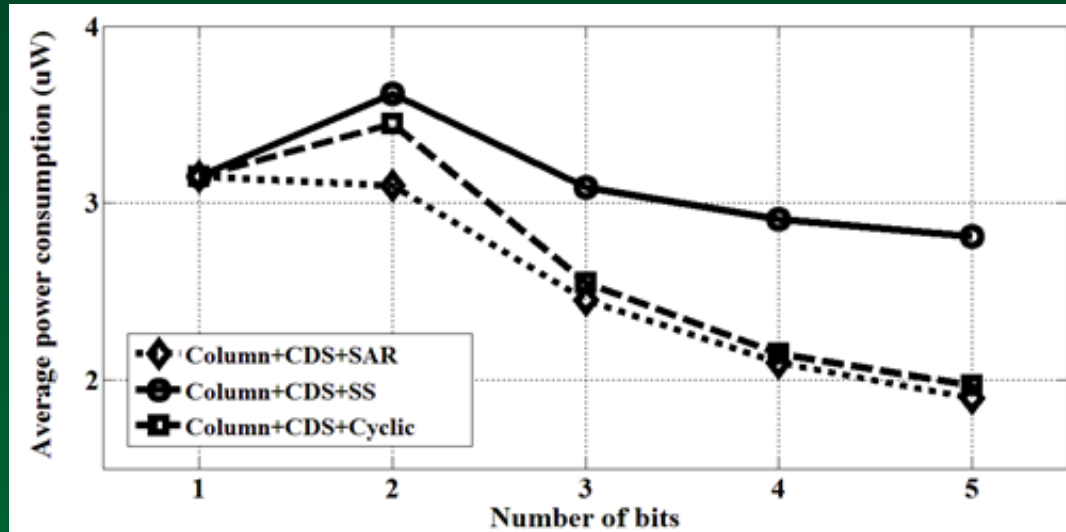
- Each jot produces 1 bit
- 1 bit ADC
- For same flux capacity, need higher frame rate readout
- Conceptual simplicity
- Easier on chip digital electronics

Multi-bit

- Each jot produces n bits
- n-bit ADC
- For same flux capacity, lower relative frame rate $1/2^{(n-1)}$
- Like current CMOS APS but low FW capacity and high conversion gain



Single Bit v. Multi-bit Power Comparison (Constant Flux Capacity)





THAYER SCHOOL OF
ENGINEERING
AT DARTMOUTH

Transforming the Jot Data Cube into Images

Rachel Zizza, Yue Song and E.R. Fossum

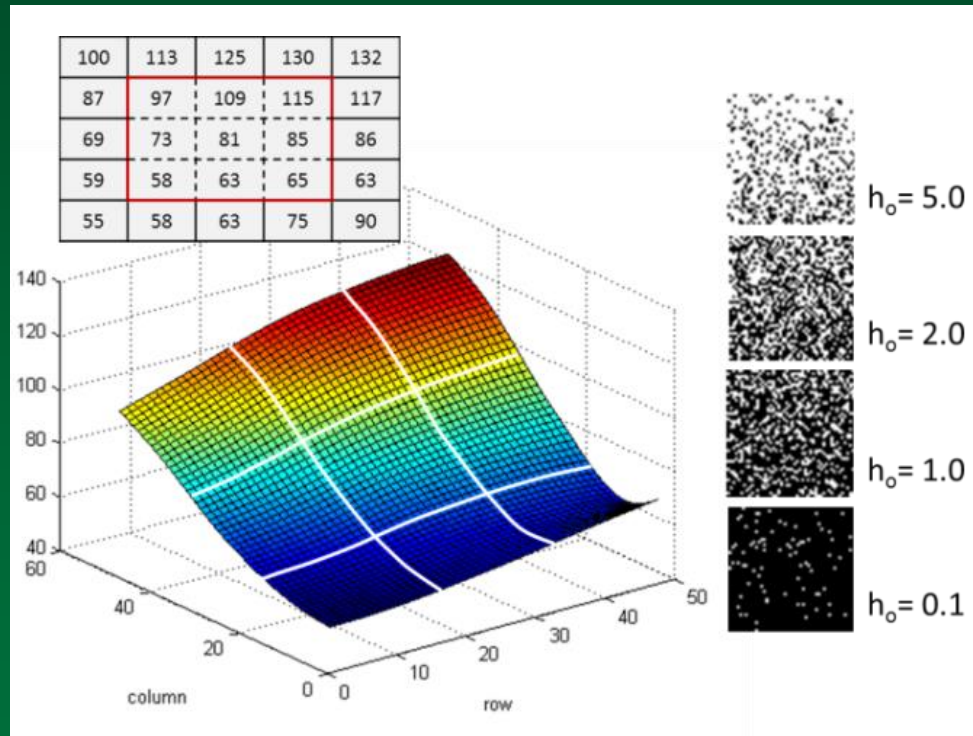
End to End System Simulation

Input Image

256x256 8b = 0.5 Mb

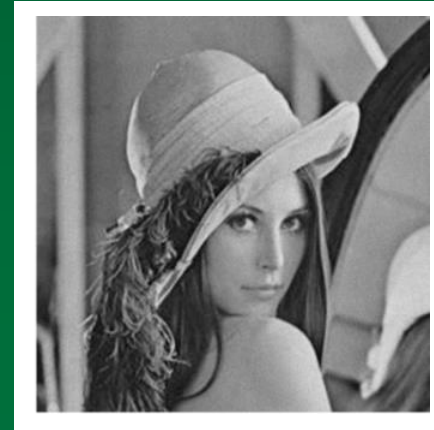


→ 4096x4096 1b x 16 fields = 256 Mb



$$H = \frac{S_H h_o}{255}$$

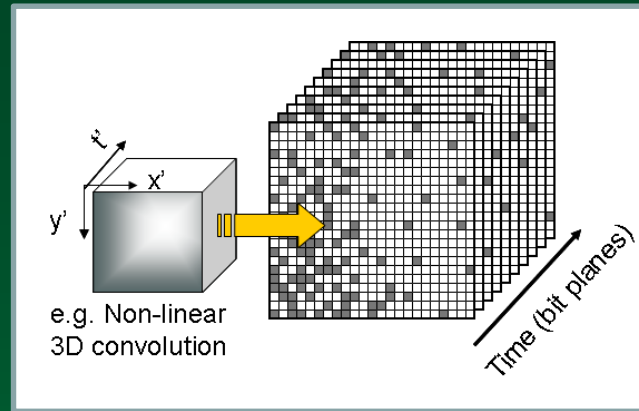
Output Image
1024x1024 8b



in this example
1 pixel = $\sum 4 \times 4 \times 16$ jots
 $SNR \leq \sqrt{256}$



Convolution

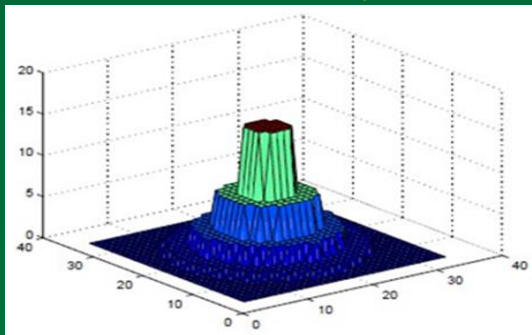


2D Examples:

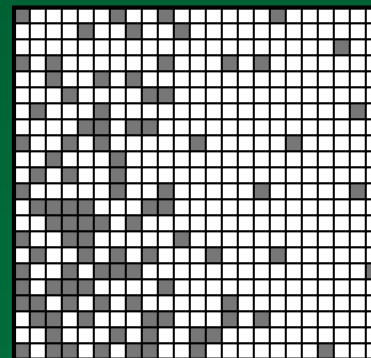
Binary
valued
filter

1	1	1	1
1	1	1	1
1	1	1	1
1	1	1	1

Binary-
weighted
filter

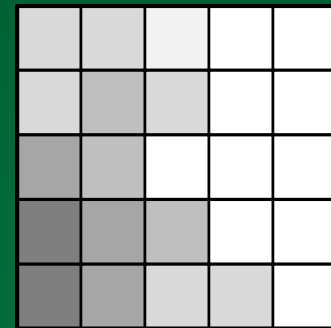


*

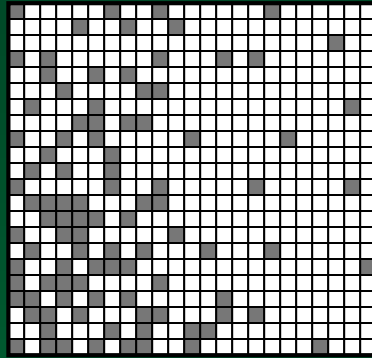


jot data

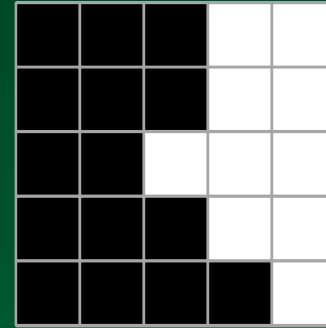
Down
sample



Digital Film Sensor Algorithm



Threshold
e.g. 3 hits
in 4x4



“gain”

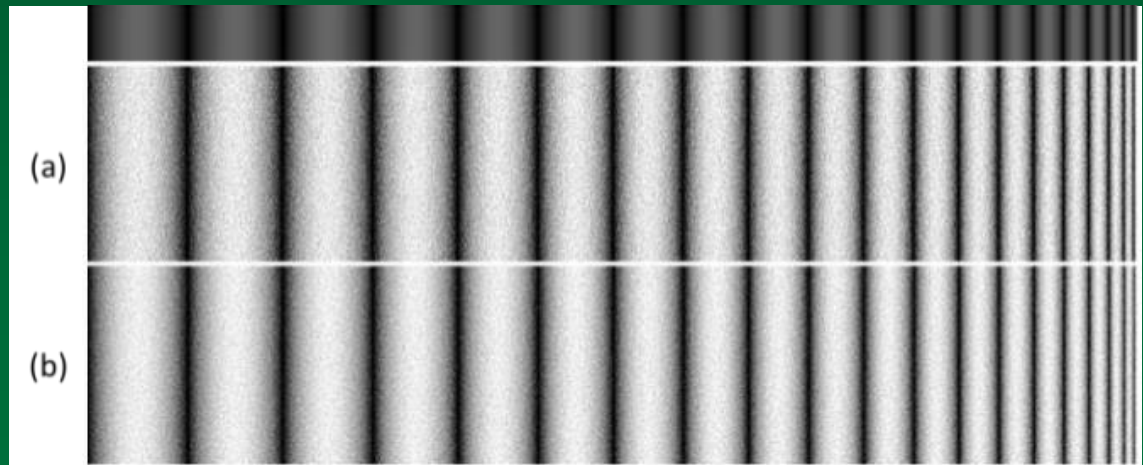
Synthetic input image



After DFS development

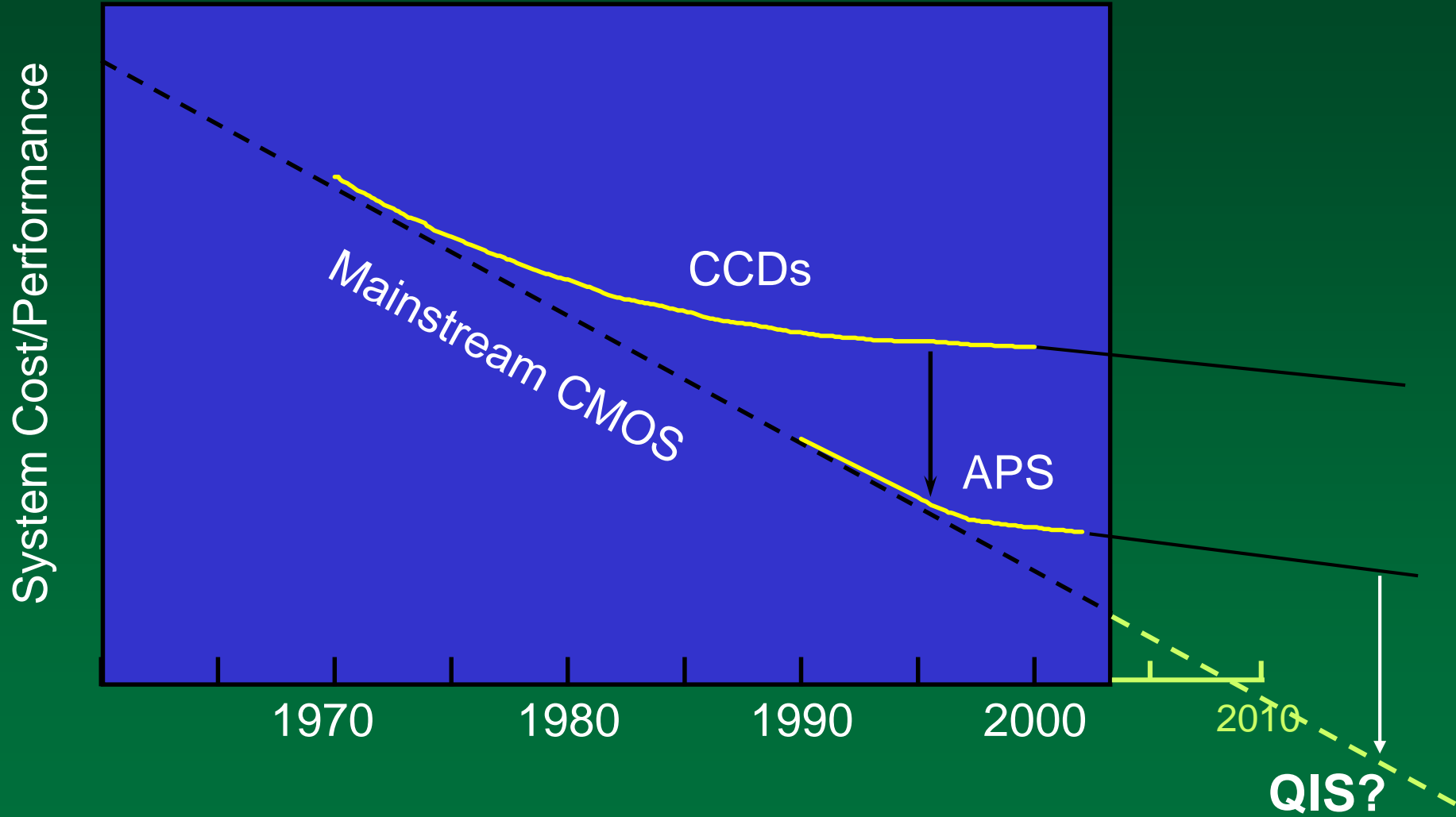


Plus filter with dynamic
kernel size





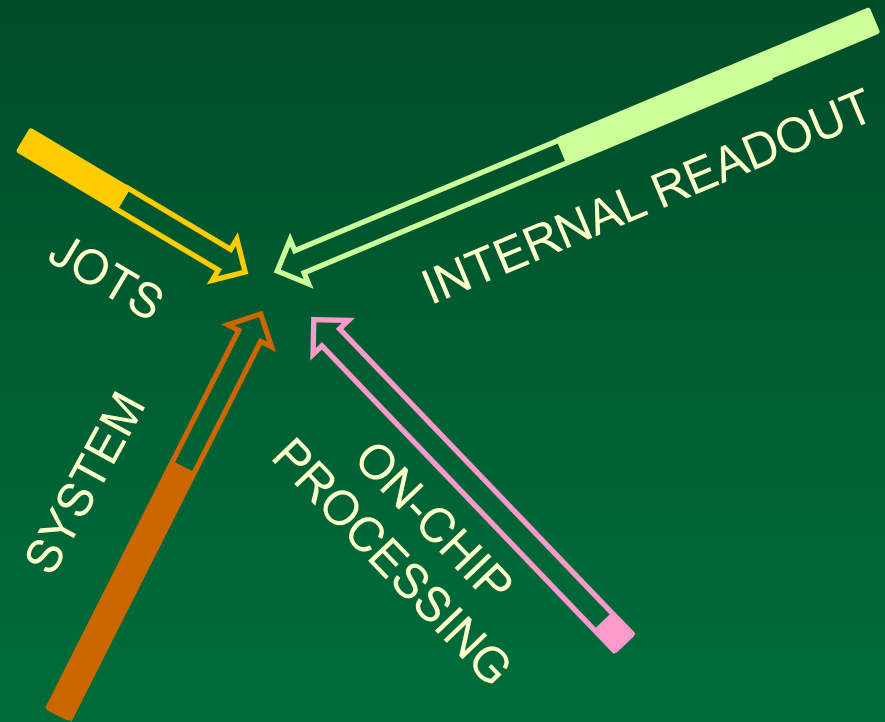
From the Late 1990's



QIS implementation requires Devices, Circuits, and System

Strawman numbers

- <500 nm jot pitch
- Gigajot QIS (10^9 jots)
- 1000 fps
- 1 Tb/s data rate
- 1 Watt or less (<1pJ/b)





Summary

- In July 2011, concept but no funding, no lab, no students
- Good progress in understanding response v. exposure, SNR, DR, etc. using photon statistics
- Progress made on realizing Quanta Image Sensor using mainstream processes
- 2-1/2 years support of Rambus (thanks Rambus!)
- Students up to speed and making great headway
- Challenges don't look as challenging
- Lots of work still to do!